# FemtoClock® NG Jitter Attenuator and Clock Synthesizer

# 8V19N407

# DATA SHEET

# **General Description**

8V19N407 is a fully integrated FemtoClock<sup>®</sup> NG Jitter Attenuator and Clock Synthesizer. The device is a high-performance clock solution for conditioning and frequency/phase management of wireless base station radio equipment boards and is optimized to deliver excellent phase noise performance. The device supports JESD204B subclass 0 and 1 clock implementations. The device is very flexible in programming of the output frequency and phase. A two-stage PLL architecture supports both jitter attenuation and frequency multiplication. The first stage PLL is the jitter attenuator and uses an external VCXO for best possible phase noise characteristics. The second stage PLL lock on the VCXO-PLL output signal and synthesizes the target frequency. The second-stage PLL use an internal VCO.

The device supports the clock generation of high-frequency clocks from the VCO and low-frequency system reference signals (SYSREF). The system reference signals are internally synchronized to the clock signals. Delay functions exist for achieving alignment and controlled phase delay between system reference and clock signals and to align/delay individual output signals. The input is monitored for activity. The "hold-over" is provided to handle clock input failure scenarios. Auto-lock, individually programmable output frequency dividers and phase adjustment capabilities are added for flexibility. The device is configured through a 4-wire SP serial interface and reports lock and signal loss status in internal registers and optionally via an lock detect (nINT) output. The device is packaged in a lead-free (RoHS 6) 72-lead VFQFN package. The extended temperature range supports wireless infrastructure, telecommunication and networking end equipment requirements. The device is a member of the high-performance clock family from IDT.

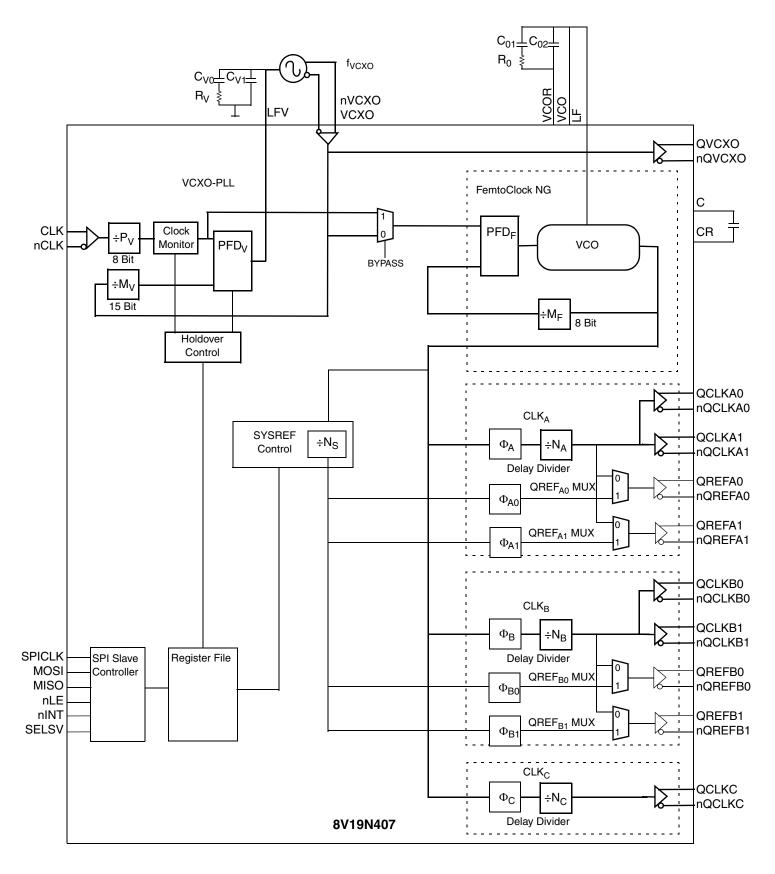
# **Features**

- Core timing unit for JESD204B wireless infrastructure clocks
- Fourth generation FemtoClock<sup>®</sup> NG technology
- First stage PLL uses an external VCXO for jitter attenuation
- Second PLL stage facilitates an integrated VCO for frequency synthesis
- 8V19N407-19: f<sub>VCO</sub> = 1900 2000MHz
- 8V19N407-24: f<sub>VCO</sub> = 2400 2500MHz
- Five differential configurable LVPECL, LVDS clock outputs with a variable output amplitude
- Four differential LVDS system reference (SYSREF) signal outputs
- Synchronization between clock and system reference signals
- Wide input frequency range supported by 8-bit pre- and 15-bit VCXO-PLL feedback divider
- Output clock frequencies: f<sub>VCO</sub> ÷ N
- Three independent output clock frequency dividers N (range of ÷1 to ÷96)
- Phase delay capabilities for alignment/delay for clock and SYSREF signals
- Individual output phase adjustment (Clock): one-period of the selected VCO frequency in 64 steps
- Individual output phase adjustment (SYSREF): approximately half-period of the selected VCO frequency in 8 steps
- Internal, SPI controlled SYSREF pulse generation
- SYSREF frequencies: f<sub>VCO</sub> ÷ N<sub>S</sub>
- SYSREF frequency dividers N<sub>S</sub>: ÷64 to ÷2048 (10 dividers)
- Clock input compatible with LVPECL, LVDS and LVCMOS signals
- Dedicated power-down features for reducing power consumption
- Input clock monitoring
- · Holdover for temporary loss of input signal scenarios
- Support of output power-down and output disable
- Typical clock output phase noise at 614.4MHz:

| 2 I I I I I I I I I I I I I I I I I I I |               |
|---|---------------|
| 1kHz offset:                            | -122.3 dBc/Hz |
| 10kHz offset:                           | -123.6 dBc/Hz |
| 100kHz offset:                          | -128.3 dBc/Hz |
| 1MHz offset:                            | -149.4 dBc/Hz |
| 10MHz offset:                           | -155.6 dBc/Hz |
|   |               |

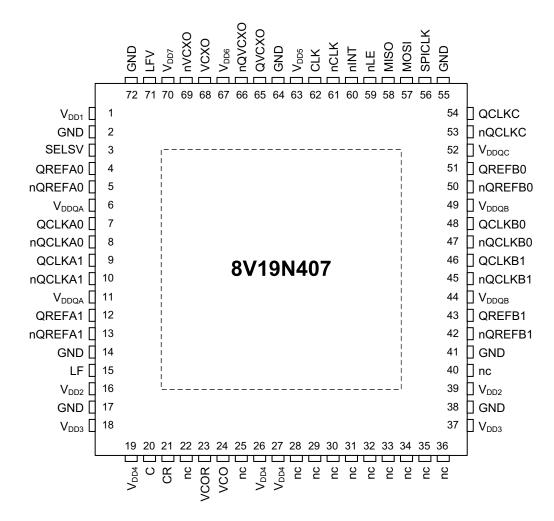
- RMS phase noise of 614.4 MHz clock (12kHz 20MHz): <100fs (typical)
- Status conditions with programmable functionality for loss-of-lock and loss of reference indication
- · Lock detect (nINT) output for status change indication
- LVCMOS/LVTTL compatible SPI serial interface
- 3.3V core and output supply mode
- Supports 3.3V I/O logic levels for all control pins
- -40°C to +85°C ambient operating temperature
- Lead-free (RoHS 6) 72-lead VFQFN package

# **Block Diagram**



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# **Pin Assignment**



72-pin, 10mm x 10mm VFQFN Package

# **Pin Description**

# Table 1. Pin Descriptions <sup>1</sup>

| Number | Name              | Туре   |        | Description  |  |  |
|--------|-------------------|--------|--------|--|--|--|
| 1      | V <sub>DD1</sub>  | Power  |        | Positive supply (3.3V) for the VCXO-PLL front end (charge pump and $P_V$ divider).               |  |  |
| 2      | GND               | Ground |        | Power supply ground. Ground current return path for pin $V_{DD1}$ . Connect to board GND (0V).   |  |  |
| 3      | SELSV             | Input  | Pullup | SPI voltage select. 3.3V LVCMOS/LVTTL interface levels   |  |  |
| 4      | QREFA0            | Output |        | Differential SYSREF/clock output A0. LVDS style for SYSREF operation,                            |  |  |
| 5      | nQREFA0           | Output |        | Configurable LVPECL, LVDS style and amplitude for clock operation.                               |  |  |
| 6      | V <sub>DDQA</sub> | Power  |        | Output supply (3.3V) for the QCLKAn and QREFAn outputs.  |  |  |
| 7      | QCLKA0            | Output |        | Differential clock output AQ, Configurable LVDECL, LVDC at the and emplitude                     |  |  |
| 8      | nQCLKA0           | Output |        | <ul> <li>Differential clock output A0. Configurable LVPECL, LVDS style and amplitude.</li> </ul> |  |  |

# Table 1. Pin Descriptions (Continued)<sup>1</sup>

| Number | Name              | Туре   | Description  |  |
|--------|-------------------|--------|--|--|
| 9      | QCLKA1            | Output | Differential clock output A1. Configurable LVPECL, LVDS style and amplitude.               |  |
| 10     | nQCLKA1           | Output |  |  |
| 11     | V <sub>DDQA</sub> | Power  | Output supply (3.3V) for the QCLKAn and QREFAn outputs.                                    |  |
| 12     | QREFA1            | Output | Differential SYSREF/clock output A1. LVDS style for SYSREF operation,                      |  |
| 13     | nQREFA1           | Output | Configurable LVPECL, LVDS style and amplitude for clock operation.                         |  |
| 14     | GND               | Power  | Power supply ground. Ground return path for the $V_{DD2}$ pins. Connect to board GND (0V). |  |
| 15     | LF                | Output | Loop filter/charge pump output for the FemtoClock NG PLL.                                  |  |
| 16     | V <sub>DD2</sub>  | Power  | Positive supply (3.3V) for the LF output.  |  |
| 17     | GND               | Power  | Power supply ground. Ground return path for the $V_{DD3}$ pins. Connect to board GND (0V). |  |
| 18     | V <sub>DD3</sub>  | Power  | Positive supply (3.3V) for the internal PLLs.  |  |
| 19     | V <sub>DD4</sub>  | Power  | Positive supply (3.3V) for the internal VCO.   |  |
| 20     | С                 | Analog | Regulator bypass capacitor. Use a 4.7µF capacitor between the C and CR pins.               |  |
| 21     | CR                | Analog |  |  |
| 22     | nc                | Unused | No internal connection. Do not use.  |  |
| 23     | VCOR              | Analog | Ground return path pin for the VCO loop filter.  |  |
| 24     | VCO               | Analog | Loop filter control voltage input to VCO.  |  |
| 25     | nc                | Unused | No internal connection. Do not use.  |  |
| 26     | V <sub>DD4</sub>  | Power  | Positive supply (3.3V) for the internal VCO.   |  |
| 27     | V <sub>DD4</sub>  | Power  | Positive supply (3.3V) for the internal VCO.   |  |
| 28     | nc                | Unused | No internal connection. Do not use.  |  |
| 29     | nc                | Unused | No internal connection. Do not use.  |  |
| 30     | nc                | Unused | No internal connection. Do not use.  |  |
| 31     | nc                | Unused | No internal connection. Do not use.  |  |
| 32     | nc                | Unused | No internal connection. Do not use.  |  |
| 33     | nc                | Unused | No internal connection. Do not use.  |  |
| 34     | nc                | Unused | No internal connection. Do not use.  |  |
| 35     | nc                | Unused | No internal connection. Do not use.  |  |
| 36     | nc                | Unused | No internal connection. Do not use.  |  |
| 37     | V <sub>DD3</sub>  | Power  | Positive supply (3.3V) for the internal PLLs.  |  |
| 38     | GND               | Power  | Power supply ground. Ground return path for the $V_{DD3}$ pins. Connect to board GND (0V). |  |
| 39     | V <sub>DD2</sub>  | Power  | Positive supply (3.3V) for the LF output.  |  |
| 40     | nc                | Unused | No internal connection. Do not use.  |  |
| 41     | GND               | Power  | Power supply ground. Ground return path for the $V_{DD2}$ pins. Connect to board GND (0V). |  |

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# Table 1. Pin Descriptions (Continued)<sup>1</sup>

| Number | Name              | Ту     | ре                   | Description  |  |
|--------|-------------------|--------|----------------------|--|--|
| 42     | nQREFB1           | Output |                      | Differential SYSREF/clock output B1. LVDS style for SYSREF operation,  |  |
| 43     | QREFB1            | Output |                      | Configurable LVPECL, LVDS style and amplitude for clock operation.   |  |
| 44     | V <sub>DDQB</sub> | Power  |                      | Output supply (3.3V) for the QREFBn and QCLKBn outputs.  |  |
| 45     | nQCLKB1           | Output |                      | Differential clock output B1. Configurable LVPECL, LVDS style and amplitude.   |  |
| 46     | QCLKB1            | Output |                      | Differential clock output DT. Configurable LVT LOL, LVDG style and amplitude.  |  |
| 47     | nQCLKB0           | Output |                      | Differential clock output B0. Configurable LVPECL, LVDS style and amplitude.   |  |
| 48     | QCLKB0            | Output |                      | Differential clock output bo. Configurable LVT ECE, LVDS style and amplitude.  |  |
| 49     | V <sub>DDQB</sub> | Power  |                      | Output supply (3.3V) for the QREFBn and QCLKBn outputs.  |  |
| 50     | nQREFB0           | Output |                      | Differential SYSREF/clock output B0. LVDS style for SYSREF operation,  |  |
| 51     | QREFB0            | Output |                      | Configurable LVPECL, LVDS style and amplitude for clock operation.   |  |
| 52     | V <sub>DDQC</sub> | Power  |                      | Output supply (3.3V) for the QCLKC output.   |  |
| 53     | nQCLKC            | Output |                      | Differential clock output C. Configurable LVPECL, LVDS style and amplitude.  |  |
| 54     | QCLKC             | Output |                      |  |  |
| 55     | GND               | Power  |                      | Power supply ground. Ground return path for the $V_{\text{DD5}}$ pins. Connect to board GND (0V).  |  |
| 56     | SPICLK            | Input  | Pulldown             | Serial Control Port SPI Clock input. 3.3V/1.8V selectable LVCMOS/LVTTL interface levels.   |  |
| 57     | MOSI              | Input  | Pulldown             | Serial Control Port SPI Data input. 3.3V/1.8V selectable LVCMOS/LVTTL interface levels.  |  |
| 58     | MISO              | Output |                      | Serial Control Port SPI Data output. 3.3V/1.8V selectable LVCMOS/LVTTL interface levels.   |  |
| 59     | nLE               | Input  | Pulldown             | Serial Control Port SPI Load Enable input. 3.3V/1.8V selectable LVCMOS/LVTTL interface levels.   |  |
| 60     | nINT              | Output |                      | Status Output pin for signaling fault conditions. 3.3V/1.8V selectable LVCMOS/LVTTL interface levels.  |  |
| 61     | nCLK              | Input  | Pullup /<br>Pulldown | Device clock inverting and non-inverting differential clock input. Inverting input is biased to 1.2V by default when left floating. Compatible with LVPECL, LVDS and |  |
| 62     | CLK               | Input  | Pulldown             | LVCMOS signals.  |  |
| 63     | V <sub>DD5</sub>  | Power  |                      | Positive supply (3.3V) for the SPI interface and the CLK, nCLK inputs.   |  |
| 64     | GND               | Power  |                      | Power supply ground. Ground return path for the $V_{\text{DD6}}$ pins. Connect to board GND (0V).  |  |
| 65     | QVCXO             | Output |                      | Differential VCXO-PLL clock output. Configurable LVPECL, LVDS style and amplitude.   |  |
| 66     | nQVCXO            | Output |                      |  |  |
| 67     | V <sub>DD6</sub>  | Power  |                      | Positive supply (3.3V) for the QVCXO output and VCXO-PLL.  |  |
| 68     | VCXO              | Input  | Pulldown             | VCXO non-inverting and inverting differential clock input. Inverting input is biased to 1.2V   |  |
| 69     | nVCXO             | Input  | Pullup /<br>Pulldown | by default when left floating. Compatible with LVPECL, LVDS and LVCMOS signals.  |  |
| 70     | V <sub>DD7</sub>  | Power  |                      | Positive supply (3.3V) for the VCXO-PLL charge pump output.  |  |

# Table 1. Pin Descriptions (Continued)<sup>1</sup>

| Number | Name        | Туре   |  | Description   |
|--------|-------------|--------|--|---|
| 71     | LFV         | Output |  | VCXO-PLL charge pump output. Connect to the loop filter for the external VCXO.  |
| 72     | GND         | Power  |  | Power supply ground. Ground return path for the $V_{\text{DD6}}$ pins. Connect to board GND (0V).   |
| _      | Exposed pad | Power  |  | Power supply ground. Ground return path for all differential outputs. Connect to board GND (0V) and to a thermally low resistive path on the board. |

NOTE 1. Pulldown and Pullup refer to internal input resistors. See Table 4B, Input/Output Characteristics, for typical values.

# **Principles of Operation**

The 8V19N407 is a dual stage PLL clock synthesizer. The first stage is the VCXO-PLL that uses an external VCXO device as a high-quality oscillator and provides jitter attenuation to the input clock signal. The second stage is a FemtoClock NG synthesizer PLL with an internal VCO for flexible output frequency generation. By configuring the 8-bit integer pre-scaler P<sub>V</sub> and the 15-bit integer feedback divider M<sub>V</sub>, the VCXO-PLL can accommodate a wide range of input and VCXO frequencies. The input (P<sub>V</sub>) and VCXO-PLL feedback (M<sub>V</sub>) dividers must be set to match the frequency of the phase detector (PFD<sub>V</sub>). The VCO of the second stage PLL is designed to support center frequencies within the specified VCO range. This VCO has its own PLL feedback divider (M<sub>F</sub>) which must be set to match the VCXO-PLL frequency (first loop) to its center frequency range. Table 2A shows the supported input, feedback and output dividers.

The output signal of the second stage FemtoClock NG PLL is then distributed to the individual clock dividers, delay stages and outputs. The device has five clock outputs (QCLK), organized in the three output banks A, B and C. Each output bank has an individual integer clock divider N for clock frequency generation. See Table 2E for a list of supported output frequencies.

The jitter-attenuated clock signal from the VCXO-PLL is routed to the QVCXO output. The phase noise of this output corresponds to the quality of the used external VCXO.

The devices supports the generation of up to four non-periodic or periodic synchronization signals (SYSREF). The SYSREF signals are generated internally from the VCO clock source, therefore the SYSREF outputs (QREF) are synchronous to the QCLK outputs. The SYSREF signals have a pulse repetition rate of  $f_{VCO} \div N_S$  (the N<sub>S</sub> divider can be configured to one of 10 frequency dividers. See Table 2A).

Each QCLK output bank signal can be individually phase-delayed to achieve a specific phase alignment relative to each other and relative to any QREF (SYSREF) clock output. The four QREF outputs can be individually re-configured as device clocks for additional flexibility.

In an alternatively operation mode, the VCXO input stage can by bypassed for applications with multiple 8V19N407 devices locking to a common source clock. In such an application, the first device acts as a jitter attenuator and the second device acts as a low phase noise frequency synthesizer. The first device provides the input signal to the second 8V19N407 at e.g. 122.88MHz. The second 8V19N407 is used in VCXO-bypass mode and its second stage PLL locks to the jitter-attenuated clock input signal of the first device. The device is configured through an SPI interface. Configurations are established by setting or resetting internal bits, which are organized in eight 32-bit words. The SPI interface also supports read-back of configuration settings.

#### Table 2A. PLL Divider Settings

| PLL Divider   | Range                                     | Operation  |
|---|---|--|
|   | nange                                     | operation  |
| $PrescalerP_{V}$  | ÷1 to ÷255<br>(8 bit)                     | Input Clock Frequency:   |
| VCXO-PLL<br>Feedback Divider<br>M <sub>V</sub>          | ÷4 to ÷32767<br>(15 bit)                  | $f_{CLK} = f_{VCXO} \cdot \frac{P_V}{M_V}$                     |
| FemtoClock NG<br>Feedback Divider<br>M <sub>F</sub>     | ÷8 to ÷255<br>(8 bit)                     | VCXO frequency:<br>$f_{VCXO} = \frac{f_{VCO}}{M_F}$            |
| Output Divider N<br>(N <sub>A</sub> to N <sub>C</sub> ) | ÷1 to ÷96<br>(18 discrete<br>dividers)    | Output frequency<br>$f_{OUT} = \frac{f_{VCO}}{N_{A, B, C}}$    |
| SYSREF Divider<br>N <sub>S</sub>                        | ÷64 to ÷2048<br>(10 discrete<br>dividers) | SYSREF<br>frequency/rate<br>$f_{SYSREF} = \frac{f_{VCO}}{N_S}$ |

# Table 2B. Example FemtoClock NG PLL Divider Settings (f<sub>VCO</sub> = 2457.6MHz)<sup>1</sup>

| VCXO Frequency (MHz) | M <sub>F</sub> Divider Settings |
|----------------------|---------------------------------|
| 153.6                | ÷16                             |
| 122.88               | ÷20                             |
| 76.8                 | ÷32                             |
| 61.44                | ÷40                             |
| 38.4                 | ÷64                             |
| 30.72                | ÷80                             |

NOTE 1. Example list of VCXO frequencies for VCO frequency of 2457.6MHz. The M<sub>F</sub> divider has a range from M<sub>F</sub> = 8 to M<sub>F</sub> = 255.  $f_{VCXO}$  = 2457.6  $\div$  M<sub>F</sub> See Table 3C for register configuration.

#### Table 2C. VCXO-PLL Bypass Settings<sup>1</sup>

| BYPASS | Operation  |
|--------|--|
| 0      | VCXO-PLL operation.  |
| 1      | VCXO-PLL bypassed. The reference clock for<br>the 2nd PLL is the input clock. Clock<br>monitoring is disabled. No jitter attenuation.<br>No external VCXO component and loop filter<br>required. |

NOTE 1. See Table 3I for register configuration.

## **Input Reference**

The 8V19N407 is designed for high-reliability applications and supports input frequency monitoring. If no activity has been detected on any clock input within a fixed time period, then the reference is considered to be invalid and an internal status flag is set. This is a loss of signal event (LOS) and sets the STAT0 status bit. See also Table 2Q for an overview of supported status functions. The VCXO-PLL provides a temporary hold-over in LOS situations.The device enters a hold-over state in any of the following cases:

- the clock signal is invalid (LOS)
- the HOLD bit is set to logic 1 (hold-over)

#### Table 2D. Holdover<sup>1</sup>

| HOLD | Operation  |
|------|--|
| 0    | Normal operation   |
| 1    | VCXO-PLL is set to holdover. The control voltage of the external VCXO is set to $V_{DD}/2$ . |

NOTE 1. See Table 3I for register configuration.

### VCXO-PLL

The charge pump current of the PLL is configurable in small steps by writing the desired charge pump current amount into a SPI register. 64 steps of  $20\mu$ A are available, the range pump current range is  $0\mu$ A to 1.26mA. See CPV[5:0], Table 3I for available settings.

### **Clock Outputs**

#### **Output Divider**

From the VCO frequency the three independent clock output dividers  $N_A$ ,  $N_B$  and  $N_C$  scale the frequency down to the desired clock output frequencies. (see Table 2E). The output dividers  $N_A$ ,  $N_B$  and  $N_C$  can be set via internal registers. The configuration and re-configuration of any of the output dividers requires the SPI write sequence described in Section, "Clock Output Divider Reset Sequence, (Sequence S1)" on page 14.

| Output Divider N <sub>A</sub> , N <sub>B</sub> , N <sub>C</sub> | Output Clock Frequency (MHz) |
|---|------------------------------|
| ÷1  | VCO Frequency ÷1             |
| ÷2  | VCO Frequency ÷2             |
| ÷3  | VCO Frequency ÷3             |
| ÷4  | VCO Frequency ÷4             |
| ÷5  | VCO Frequency ÷5             |
| ÷6  | VCO Frequency ÷6             |
| ÷8  | VCO Frequency ÷8             |
| ÷10   | VCO Frequency ÷10            |
| ÷12   | VCO Frequency ÷12            |
| ÷16   | VCO Frequency ÷16            |
| ÷20   | VCO Frequency ÷20            |
| ÷24   | VCO Frequency ÷24            |
| ÷32   | VCO Frequency ÷32            |
| ÷40   | VCO Frequency ÷40            |
| ÷48   | VCO Frequency ÷48            |
| ÷64   | VCO Frequency ÷64            |
| ÷80   | VCO Frequency ÷80            |
| ÷96   | VCO Frequency ÷96            |

#### Table 2E. N<sub>A, B, C</sub> Frequency Divider Settings<sup>1</sup>

NOTE 1. Individual setting for each output bank A, B and C. See Table 3E for register configuration.

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#### Table 2F. N<sub>A, B, C</sub> Example Frequency Divider Settings

| Output Divider                                   | Output Clock Frequency (MHz) for a VCO<br>Frequency of |                        |                      |  |
|--|--|------------------------|----------------------|--|
| N <sub>A</sub> , N <sub>B</sub> , N <sub>C</sub> | 1920MHz <sup>1</sup>                                   | 2457.6MHz <sup>2</sup> | 2500MHz <sup>3</sup> |  |
| ÷1   | 1920   | 2457.6                 | 2500                 |  |
| ÷2   | 960  | 1228.8                 | 1250                 |  |
| ÷3   | 640  |                        |                      |  |
| ÷4   | 480  | 614.4                  | 625                  |  |
| ÷5   | 384  | 491.52                 | 500                  |  |
| ÷6   | 320  |                        |                      |  |
| ÷8   | 240  | 307.2                  | 312.5                |  |
| ÷10  | 192  | 245.76                 | 250                  |  |
| ÷12  | 160  |                        |                      |  |
| ÷16  | 120  | 153.6                  | 156.25               |  |
| ÷20  | 96   | 122.88                 | 125                  |  |
| ÷24  | 80   |                        |                      |  |
| ÷32  | 60   | 76.8                   | 78.125               |  |
| ÷40  | 48   | 61.44                  | 62.5                 |  |
| ÷48  | 40   | 51.2                   |                      |  |
| ÷64  | 30   | 38.4                   |                      |  |
| ÷80  | 24   | 30.72                  | 31.25                |  |
| ÷96  | 20   | 25.6                   |                      |  |

NOTE 1. 1920MHz: 8V19N407-19 NOTE 2. 2457.6MHz: 8V19N407-24

NOTE 3. 2500MHz: 8V19N407-24

#### **Output Format**

All differential device clock outputs (QCLK) can be individually configured in format (LVPECL, LVDS), output amplitude, state (enable, disable) and power state (power on, power off). Outputs in LVPECL format are terminated to a termination voltage V<sub>T</sub> according to the configured output amplitude. Outputs in LVDS format are terminated 100 $\Omega$  across the terminals. The outputs of the 8V19N407 was designed for flexibility in amplitude control. The output offset voltage changes with amplitude. For strict LVDS compliance, it is recommended to AC-couple the LVDS outputs and re-bias to V<sub>BIAS</sub> = 1.25V. The lowest output amplitude settings correspond with the least amount of power consumed. Unused clock outputs may not be terminated externally to save current consumption. The QCLK outputs LVPECL, LVDS format configuration is shown in Table 2G. For LVPECL format, set EF = 1 and terminate the LVPECL output pair 50 $\Omega$  to the specified recommended termination voltage shown in Table 2G. For LVDS format, set EF = 0 and terminate the output pair  $100\Omega$  across the QCLK, nQCLK terminals. Independent on the state of the EF bit, the A[1:0] bits control the output amplitude of QCLK outputs.

### Table 2G. QCLK Output Control<sup>1</sup>

| EF | <b>A</b> [1]    | A[0]                                   | Output Operation                     | Output Termination                     |  |  |  |
|----|-----------------|--|--------------------------------------|--|--|--|--|
|    | LVPECL (EF = 1) |  |                                      |  |  |  |  |
| 1  | 0               | 0                                      | Power off                            | Do not terminate                       |  |  |  |
| 1  | 0               | 1                                      | 400mV                                | 50 $\Omega$ to V <sub>DDx</sub> - 1.5V |  |  |  |
| 1  | 1               | 0                                      | 700mV                                | 50 $\Omega$ to V <sub>DDx</sub> - 2V   |  |  |  |
| 1  | 1               | 1 1000mV,<br>f <sub>OUT</sub> > 500MHz |                                      | 50 $\Omega$ to V_{DDx} - 2.5V          |  |  |  |
|    | LVDS (EF = 0)   |  |                                      |  |  |  |  |
| 0  | 0               | 0                                      | Power off                            | 100 $\Omega$ across                    |  |  |  |
| 0  | 0               | 1                                      | 400mV                                | 100 $\Omega$ across                    |  |  |  |
| 0  | 1               | 0                                      | 700mV                                | 100 $\Omega$ across                    |  |  |  |
| 0  | 1               | 1                                      | 1000mV,<br>f <sub>OUT</sub> > 500MHz | $100\Omega$ across                     |  |  |  |

NOTE 1. Individual setting for each output QCLKA[1:0], QCLKB[1:0] and QCLKC.

Each QCLK output can be individually disabled to the logic low state by clearing the corresponding OUTEN bit. See Table 2H for details.

#### Table 2H. QCLK Output Enable<sup>1</sup>

| OUTEN | Output Operation                    |
|-------|-------------------------------------|
| 0     | QCLK is disabled in logic low state |
| 1     | QCLK is enabled                     |

NOTE 1. Individual setting for each output QCLKA[1:0], QCLKB[1:0] and QCLKC.

**Clock channel power**: Setting the corresponding nPOWER bit will power-down the N divider and delay stage of an clock output channel to save operating currents in situations of an output channel not used for frequency generation.

#### Table 2I. Clock Channel Power Operation<sup>1</sup>

| nPOWER | Clock Channel                                 |
|--------|---|
| 0      | Divider N and delay stage $\Phi$ powered up   |
| 1      | Divider N and delay stage $\Phi$ powered down |

NOTE 1. Individual setting for each clock channel A, B and C (dividers N<sub>A</sub>, N<sub>B</sub>, N<sub>C</sub> and clock delay stages  $\Phi_A$ ,  $\Phi_B$ ,  $\Phi_C$ ). See Table 3E for register configuration.

## SYSREF Outputs (QREF)

Each QREF output can be individually configured as SYSREF output or as clock output by setting the corresponding MUX bit. For JESD204B-operation, configure QREF outputs as SYSREF outputs. See Table 2J for details.

#### Table 2J. QREF Output Configuration<sup>1</sup>

| QREF MUX | Operation  |
|----------|--|
|          | Clock Mode   |
|          | <ul> <li>Frequency divided by N</li> </ul>   |
| 0        | <ul> <li>Output amplitude: use any setting in<br/>Table 2K</li> </ul>  |
| 0        | <ul> <li>Set nPOWER = 1 to power down the corresponding (unused) SYSREF delay stage Φ<sub>A0-B1</sub></li> <li>Set OUTEN = 1 (output enable)</li> </ul>  |
| 1        | <ul> <li>SYSREF Mode (JESD204B)</li> <li>Set nPOWER = 0 to power up the corresponding SYSREF delay stage Φ<sub>A0-B1</sub></li> <li>Set the QREF output amplitude to 400mV (A[1:0] = 01)</li> <li>Set OUTEN = 1 (output enable)</li> </ul> |

NOTE 1. Individual setting for each output QREF output QREFA[1:0], QREFB[1:0].

**Clock mode (MUX = 0):** QREF outputs operate as additional clock outputs, increasing the available clock signal fanout. In this mode, the output amplitude can be configured to one of three different values. In clock mode, the output frequency of is controlled by the N divider of the corresponding device clock output. For instance, the divider N<sub>A</sub> controls the output frequency of both QCLKA0, A1 and QREFA0, A1. The QREF output delay setting is controlled by the delay circuit  $\Phi$  of the associated clock output QCLK. See Table 2K for details.

#### Table 2K. QREF Output Control (MUX = 0)

| OUTEN | A[1] | A[0] | Output Operation  |
|-------|------|------|---|
| x     | 0    | 0    | QREF output buffer<br>powered down                        |
| 0     | 0    | 1    |   |
| 0     | 1    | 0    | <ul> <li>QREF disabled in logic<br/>low state</li> </ul>  |
| 0     | 1    | 1    |   |
| 1     | 0    | 1    | V <sub>O, PP</sub> = 400mV                                |
| 1     | 1    | 0    | V <sub>O, PP</sub> = 700mV                                |
| 1     | 1    | 1    | V <sub>O, PP</sub> = 1000mV,<br>f <sub>OUT</sub> > 500MHz |

JESD204B (SYSREF) Operation (MUX = 1): The QREF outputs support the generation of SYSREF pulses in JESD204B applications. The delay stages can be used to establish repeatable phase relationships of QCLK outputs to each other and to the SYREF signals QREF: the QCLK delay stages support 64 steps of delay and the QREF outputs support additional 8 steps of fine-delay. See Table 2P and Section, "SYSREF Generation" on page 12. Each individual QREF output can also be disabled into logic low state by clearing the OUTEN bit. For SYSREF operation, the QREF outputs should be configured as shown in Table 2L:

#### Table 2L. QREF Output Control<sup>1</sup> (SYSREF, MUX = 1)

| A[1] | A[0] | Output Operation           | Output Termination |
|------|------|----------------------------|--------------------|
| 0    | 0    | Power off                  | $100\Omega$ across |
| 0    | 1    | V <sub>O, PP</sub> = 400mV | 100Ω across        |

NOTE 1. Individual setting for each output QREF output QREFA[1:0], QREFB[1:0].

**SYSREF power down features**: Setting the corresponding nPOWER bit will power-down the  $\Phi$  delay circuit. A QREF output buffer can be powered-down by setting A[1:0] = 00. The QREF outputs automatically power-down when SRO = 0 (counted pulse mode) and no SYSREF pulses are generated. QREF outputs will power up automatically for SYSREF pulse generation, controlled by the SYSREF generation sequence (see Section, "QREF Phase Delay and SYSREF Synchronization Sequence, (Sequence S2)" on page 14). Applications not using a QREF output should power the delay circuit down (nPOWER = 1) and also power off the output buffer (set MUX = 0, A[1:0] = 00). Powered-down output buffers save operating current even with presence of external terminations. See Table 2M and Table 2K for details.

### Synchronization and Phase Alignment

#### **QCLK Outputs**

The 8V19N407 has output dividers which generate the supported clock frequencies at outputs QCLK synchronously. After the SPI controlled synchronization of output dividers, all output clocks QCLK will be in alignment with each other. Outputs which selected different output dividers are aligned on the incident rising edge.

#### **QCLK Delay Circuits**

The clock outputs QCLK have an individual delay element ( $\Phi$ ) to advance/delay its clock output phase of an clock output bank if an offset is desired on a particular output. The delay circuit operates by inserting a delay into the clock signal coming out of the individual QCLK bank outputs by a discrete number of one clock period of the FemtoClock NG VCO. The user may select a number of steps to insert via the appropriate register. Each of the two output banks supports 64 steps of phase delay (the delay unit is a function of the internal VCO frequency. See Table 2O). For fine delay, the SYSREF outputs have individual phase delay circuits, each delay circuit supports eight steps. See Table 2P.

The delay capabilities of the clock and SYSREF outputs can be used to establish a specific, repeatable phase relationship between any QCLK and QREF outputs. QREF outputs that are configured with the same delay value are aligned to each other.

#### Table 2M. $\Phi_A, \Phi_B, \Phi_C$ QCLK Phase Delay<sup>1</sup>

|            | Phase Delay ( $\Phi$ ) in ns | Phase Delay ( $\Phi$ ) in ns for a VCO Frequency of: |                        |                             |  |
|------------|------------------------------|--|------------------------|-----------------------------|--|
| Delay Unit | $\frac{1}{f_{VCO}}$          | 1920MHz <sup>2</sup>                                 | 2457.6MHz <sup>3</sup> | 2500MHz <sup>4</sup>        |  |
| 0          | 0                            | 0  | 0                      | 0                           |  |
| 1          | 1 · 1/f <sub>VCO</sub>       | 0.520  | 0.406                  | 0.400                       |  |
| 2          | 2 · 1/f <sub>VCO</sub>       | 1.041  | 0.8138                 | 0.800                       |  |
|            |                              |  |                        |                             |  |
| Φ          | $\Phi \cdot 1/f_{VCO}$       | $\mathbf{\Phi} \cdot 0.520$                          | $\Phi \cdot 0.406$     | $\mathbf{\Phi} \cdot 0.400$ |  |
|            |                              |  |                        |                             |  |
| 63         | 63 · 1/f <sub>VCO</sub>      | 32.812   | 25.634                 | 25.200                      |  |

NOTE 1. Individual setting for each clock output Bank A, B and C.

NOTE 2. 1920MHz: 8V19N407-19.

NOTE 3. 2457.6MHz: 8V19N407-24.

NOTE 4. 2500MHz: 8V19N407-24.

#### Table 2N. $\Phi_{A0}$ , $\Phi_{A1}$ , $\Phi_{B0}$ , $\Phi_{B1}$ SYSREF Phase Delay<sup>1 2</sup>

|       |        |   | Phase Delay ( $\Phi$ ) in ns for a VCO Frequency (f <sub>VCO</sub> ) of: |         |            |  |
|-------|--------|---|--|---------|------------|--|
| Delay | y Unit | Delay                                   | 1920MHz  | 2500MHz | 2949.12MHz |  |
| 0     | 000    | 0                                       | 0.000  | 0.000   | 0.000      |  |
| 1     | 001    | t <sub>Delay</sub>                      | 0.165  | 0.165   | 0.165      |  |
| 2     | 010    | 1/f <sub>VCO</sub>                      | 0.521  | 0.339   | 0.407      |  |
| 3     | 011    | t <sub>Delay</sub> + 1/f <sub>VCO</sub> | 0.686  | 0.504   | 0.572      |  |
| 4     | 100    | 2/f <sub>VCO</sub>                      | 1.042  | 0.678   | 0.814      |  |
| 5     | 101    | t <sub>Delay</sub> + 2/f <sub>VCO</sub> | 1.207  | 0.843   | 0.979      |  |
| 6     | 110    | 3/f <sub>VCO</sub>                      | 1.563  | 1.017   | 1.221      |  |
| 7     | 111    | t <sub>Delay</sub> + 3/f <sub>VCO</sub> | 1.728  | 1.182   | 1.386      |  |

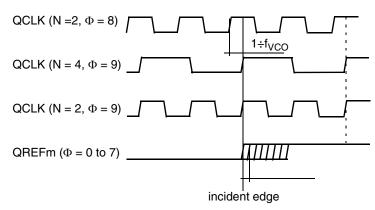
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NOTE 1. t<sub>Delay</sub> is implemented by inserting a buffer delay of 165ps (±20% tolerance).

NOTE 2. Individual setting for each SYSREF delay stages. See Table 3G for register configurations.

#### **QREF (SYSREF) to QCLK Phase Alignment**

The QREF outputs have a deterministic phase relation to the QCLK outputs. The delay circuits in both QCLK and QREF paths add phase offset to configure the phase relationship of each QCLK and QREF pair. There are 64 delay steps for each QCLK output bank and additional 8 delay steps on each QREF output. The QCLK delay unit is equal to one VCO period, the QREF delay unit is equal to approximately one half VCO period (fine delay). Each QCLK output bank and each QREF output can be individually advanced, aligned or delayed with respect to an incident QCLK rising edge. See Figure 1: For phase alignment between the incident edge of QCLK outputs and QREF, set the phase delay to  $\Phi = 9$  (QCLK) and  $\Phi = 0$  (QREF). As a pre-condition for alignment of SYSREF pulses to the incident clock edge, set the SYSREF synchronizer divider to the least common multiple value of clock dividers  $N_A$  and  $N_B$  (see Table 3K).





#### **SYSREF** Generation

The QREF outputs generate SYSREF signal pulses that support JESD204B synchronization functions. Following SYSREF pulse generation modes are available and configurable by SPI:

- Counted pulse mode: 1 to 255 pulses are generated by the device. SYSREF activity stops automatically after the transmission of the selected number of pulses and the QREF output powers down.
- Continuous mode. The SYSREF signal is a clock signal.

#### Table 20. SYSREF Generation<sup>1 2</sup>

The generation of SYSREF pulses is configured by SPI commands and is available after the initial setup of output clock divider and QREF phase delay stages.

An essential part of the SYSREF generation is the sequence of SPI commands to apply to synchronize the SYSREF pulses to the clock divider and delay state machines.

|     |                      | NS   |   |   |                | SYSREF C | SYSREF Operation (f <sub>SYSREF</sub> ) for f <sub>VCO</sub> (MHz) |          |  |
|-----|----------------------|--|---|---|----------------|----------|--|----------|--|
| SRO | 3                    | 2  | 1 | 0 | N <sub>S</sub> | 1920     | 2457.6   | 2500     |  |
|     |                      | Counted Pulse Mode<br>(Use the SRPC register to configure the number of generated SYSREF pulses) |   |   |                |          |  |          |  |
|     | 0                    | 0  | 0 | 0 | ÷64            | 30       | 38.4   | 39.0625  |  |
|     | 0                    | 0  | 0 | 1 | ÷96            | 20       | 25.6   | 26.04166 |  |
|     | 0                    | 0  | 1 | 0 | ÷128           | 15       | 19.2   | 19.53125 |  |
|     | 0                    | 0  | 1 | 1 | ÷192           | 10       | 12.8   | 13.02083 |  |
| 0   | 0                    | 1  | 0 | 0 | ÷256           | 7.5      | 9.6  | 9.76562  |  |
|     | 0                    | 1  | 0 | 1 | ÷384           | 5        | 6.4  | 6.51041  |  |
|     | 0                    | 1  | 1 | 0 | ÷512           | 3.75     | 4.8  | 4.88281  |  |
|     | 0                    | 1  | 1 | 1 | ÷768           | 2.5      | 3.2  | 3.25520  |  |
|     | 1                    | 0  | 0 | 0 | ÷1024          | 1.875    | 2.4  | 2.44140  |  |
|     | 1                    | 0  | 0 | 1 | ÷2048          | 0.9375   | 1.2  | 1.22070  |  |
|     | Continues Pulse Mode |  |   |   |                |          |  |          |  |
|     | 0                    | 0  | 0 | 0 | ÷64            | 30       | 38.4   | 39.0625  |  |
|     | 0                    | 0  | 0 | 1 | ÷96            | 20       | 25.6   | 26.04166 |  |
|     | 0                    | 0  | 1 | 0 | ÷128           | 15       | 19.2   | 19.53125 |  |
|     | 0                    | 0  | 1 | 1 | ÷192           | 10       | 12.8   | 13.02083 |  |
| 1   | 0                    | 1  | 0 | 0 | ÷256           | 7.5      | 9.6  | 9.76562  |  |
|     | 0                    | 1  | 0 | 1 | ÷384           | 5        | 6.4  | 6.51041  |  |
|     | 0                    | 1  | 1 | 0 | ÷512           | 3.75     | 4.8  | 4.88281  |  |
|     | 0                    | 1  | 1 | 1 | ÷768           | 2.5      | 3.2  | 3.25520  |  |
|     | 1                    | 0  | 0 | 0 | ÷1024          | 1.875    | 2.4  | 2.44140  |  |
|     | 1                    | 0  | 0 | 1 | ÷2048          | 0.9375   | 1.2  | 1.22070  |  |

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NOTE 1. SRO and SRPC are global settings. See Table 2P for the setting sequence to apply.

NOTE 2. SYSREF setting should only be used with 400mV and 700mV amplitude setting.

#### **QCLK Phase Delay and SYSREF Synchronization Sequence (S2)**

Precondition: Delay circuits are set to powered-up (nPOWER = 0). Set MUX = 1 to assign the SYSREF function to the QREF outputs, N<sub>S</sub> to the SYSREF pulse rate and configure the SYSREF synchronizer divider value to the least common multiple value of N<sub>A</sub> and N<sub>B</sub>.

- Write SR\_REQ0 = 1 (register 5). QREF outputs will power up.
- Write SR\_REQ1 = 1 (register 25): N<sub>S</sub> dividers are reset and synchronize.
- Write SR\_RESET = 1 (register 29): Continuous clocks or a number of specified pulses will be generated at QREF outputs.

See Table 2P for detailed description of the sequences.

|     | SYSREF     |  |
|-----|------------|--|
| SRO | Pulse Mode | Operation  |
| 0   | Counted    | <ul> <li>Pre-condition:</li> <li>MUX = 1, nPOWER = 0, A[1:0] = 01</li> <li>OUTEN = 1</li> <li>SPRC[7:0] contains the number of pulses to generate (1255)</li> <li>NS[3:0] contains the SYSREF divider</li> <li>SYNC[3:0] is set to the least common multiple value of N<sub>A</sub> and N<sub>B</sub>.</li> <li>Start operation: apply sequence S2</li> <li>QREF output will power-up for SYSREF pulse generation.</li> <li>The programmed number of SYSREF pulses is generated</li> <li>QREF output will power down automatically</li> <li>The three SR_REQ0, 1 and SR_RESET bits clear automatically</li> <li>Repeated use: apply sequence (S2) at any time</li> </ul> |
| 1   | Continues  | <ul> <li>Pre-condition:</li> <li>A[1:0] = 01</li> <li>MUX = 1, nPOWER = 0</li> <li>OUTEN=1</li> <li>NS[3:0] contains the SYSREF divider</li> <li>SYNC[3:0] is set to the least common multiple value of N<sub>A</sub> and N<sub>B</sub>.</li> <li>Start operation: apply sequence S2</li> <li>Stop operation: Set SRO = 0</li> <li>Restart function: Set SRO = 1 and apply sequence S2</li> </ul>  |

#### Table 2P. SYSREF Generation Sequence

# Device Start-up, Reset and Synchronization

After the 8V19N407 first powers-up, an internal reset signal is auto-generated. The registers are initialized with the default values listed in the table for each register.

During startup, it is not required to apply an input clock to the CLK input: the VCXO-PLL will "free-run" with the frequency of the external VCXO. The control voltage to the external VCXO (LFV pin) will be held at  $V_{DD}/2$  to support fast PLL lock and the VCXO-PLL will begin operation with their charge pumps in the middle of their operating range.

As a second step, the user should write the desired PLL dividers. Configure other operation settings such the output divider, SYSREF divider and output phase delay settings into the registers and apply software-controlled divider reset and QREF phase delay stage synchronization sequences. This is done by two separate SPI-controlled reset procedures which should be applied in the order below. First, apply the output divider reset sequence:

#### **Clock Output Divider Reset Sequence, (Sequence S1)**

- step 1: write logic 1 to the NR\_REQ0 register bit
- step 2: write logic 1 to the NR\_REQ1 register bit
- step 3: write logic 1 to the NR\_RESET bit

This completes the reset of the output divider stages. Each subsequent change of any N output divider value requires to re-apply above divider reset sequence.

Then, configure the delay stages and when completed, apply the second sequence to synchronize the QREF output delay stages:

# QREF Phase Delay and SYSREF Synchronization Sequence, (Sequence S2)

- step 1: write logic 1 to the SR\_REQ0 register bit
- step 2: write logic 1 to the SR\_REQ1 register bit
- step 3: write logic 1 to the SR\_RESET bit

This completes the synchronization of the delay stages. The clock divider reset sequence and the QREF phase delay & SYSREF synchronization sequence must be done in two separate SPI write cycles (do not combine both sequences in a single SPI write).

If sequences S1 and S2 are programmed in any order other than that which is recommended, this could result in an unknown state of the SYSREF generation. In order to reactivate the SYSREF Synchronization Sequence, power down QREF outputs by programming nPOWER bits to "1". The device is now ready for a new SYSREF Synchronization Sequence.

Any change of the output divider values or delay stage configuration requires to re-apply initialization/ synchronization through the respective SPI sequence individually.

When synchronizing the output delay stages through the synchronization sequence, care must be taken prevent writing a logic 1 to the NR\_REQ0, NR\_REQ1, NR\_RESET register bits in the same base register write cycle (write a logic 0 to these bits, which will not affect them).

The QREF phase delay and SYSREF synchronization sequence is also used to trigger the synchronized generation of SYSREF pulses. The last steps, it is recommended to clear all interrupts in preparation to start monitoring the devices status bits.

# **Status Conditions & Interrupts**

The 8V19N407 has an interrupt output to signal changes in status conditions. Settings for status conditions may be accessed in the Status and Interrupt Enable registers. The 8V19N407 has several conditions that can indicate faults and status changes in the operation of the device. These are shown in Table 2Q and can be monitored directly in the status registers. A changed bit on any or all of these can be programmed to generate an interrupt signal (nINT) via settings in the Interrupt Enable registers.

#### Table 2Q. Status Bit Functions

|          |                 | Status if Bit is: |                  |
|----------|-----------------|-------------------|------------------|
| Bit Name | Function        | 1                 | 0                |
| STAT2    | VCO calibration | Completed         | Not<br>completed |
| STAT1    | VCXO-PLL        | Locked            | Unlocked         |
| STAT0    | CLK state       | Active            | LOS              |

For the reference monitor circuit, if there has been no activity on the reference input for three consecutive clock edges (of the feedback 1st-stage VCXO signal) then the appropriate status bit will transition to a 0. It will not return to 1 until activity has resumed for three clock edges.

The lock detect circuit operate by monitoring the loop filter voltage on the first PLL (VCXO-PLL). If the monitored voltage exceeds a range, this indicates an out-of-lock condition.

It is normal when attempting to achieve lock for there to be multiple times when an out-of-lock condition as described above would occur before a full, stable lock is achieved. To prevent a bouncing status, the lock detect bit will not become asserted until the lock is stable. Once a stable lock has been achieved, this de-bounce circuit is deactivated so the lock-detect bit will de-assert immediately if a subsequent out-of-lock condition occurs.

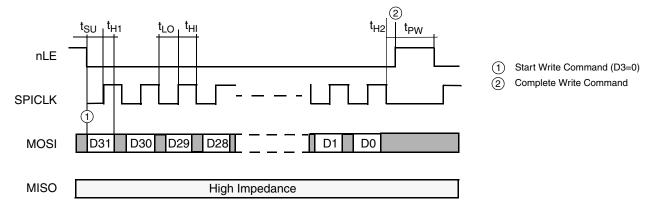
The Interrupt and Interrupt Enable registers are used to control the behavior of the nINT output based on changes in the status indicators. If any of the status indicators STAT[1:0] change, that will set the corresponding INT[1:0] bit of the Interrupt registers. If any of the INT[1:0] bits are set and their corresponding interrupt enable bit INTEN[1:0] is asserted, it will generate an interrupt (low level on nINT).

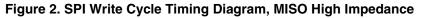
Interrupts are cleared by writing a 1 to the appropriate INT[1:0] bit(s) in the Interrupt register after the underlying fault condition has been resolved. When all valid interrupt sources have been cleared in this manner, this will release the nINT output until the next unmasked fault.

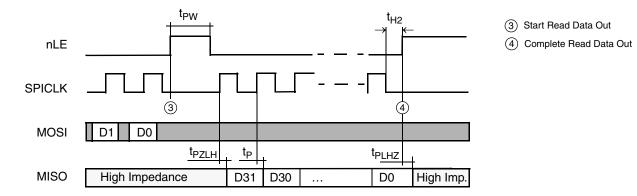
#### SPI Mode Operation with MISO Output in High Impedance

SPI mode slave operation requires that some function external to the 8V19N407 has performed any necessary serial bus arbitration and/or address decoding at the level of the board or system. By default, the MISO data output is in high-impedance state. The 8V19N407 begins a cycle by detecting an asserted (low) state on the nLE input at a rising edge of SPICLK. This is also coincident with the first bit of data being shifted into the device. In SPI mode, the first bit is the Most Significant Bit (MSB) of the data word being written. Data must be written in 32-bit words, with nLE remaining asserted and one data bit being shifted in to the 8V19N407 on every rising edge of SPICLK. If nLE is deasserted (high) at any time except following the 32<sup>nd</sup> falling edge of SPICLK, then this is treated as an error and the shift register contents are discarded. No data is written to any internal registers. If nLE is deasserted (high) as expected after the 32<sup>nd</sup> falling edge of SPICLK, then this will result in the shift register contents being acted on according to the instructions (address + R/W) in it. During write operation, the MISO output remains in high-impedance state. The word format of the 32-bit quantity in the shift register is shown in Figure 2. The register fields in the 8V19N407 have been organized

so that the 4 LSBs in each 32-bit register row are not used for data transfer. Three of these bits will represent the base address for the eight 32-bit base registers and the 4th bit indicates whether a read or write operation is requested. If a read operation is requested, 32-bits of read data will be provided in the immediately subsequent access. The nLE must be deasserted (high) and then reasserted (low). On the first SPICLK rising edge, once nLE is re-asserted to low state, the MISO output will turn to active state and one data bit will be placed on the MISO output at each rising edge of SPICLK as long as nLE remains asserted (low). If nLE is deasserted (high) before 32-bits of read data have been shifted out, the read cycle will be considered to be completed. If nLE remains asserted (low) longer than 32-bit times, then the data during those extra clock periods will be undefined. The MSB of the data will be presented first. When nLE is de-asserted (high), the MISO output will go into high impedance state and the SPI bus is available for transactions with other devices.









# Table 2R. SPI Read / Write Cycle Timing Parameters

| Symbol            | Parameter  | Parameter Test Condition Minimum |    | Maximum | Unit |  |
|-------------------|--|----------------------------------|----|---------|------|--|
| f <sub>CLK</sub>  | SPICLK frequency   |                                  | -  | 20      | MHz  |  |
| t <sub>SU</sub>   | nLE, MOSI setup time to SPICLK   |                                  | 15 | -       | ns   |  |
| t <sub>H1</sub>   | SPICLK to nLE, MOSI hold time  |                                  | 10 | -       | ns   |  |
| t <sub>H2</sub>   | SPICLK falling edge to nLE rising edge, hold time                      |                                  | 10 | -       | ns   |  |
| t <sub>LO</sub>   | SPICLK low period  |                                  | 25 | -       | ns   |  |
| t <sub>HI</sub>   | SPICLK high period   |                                  | 25 | -       | ns   |  |
| t <sub>PW</sub>   | nLE deasserted pulse width   |                                  | 50 | -       | ns   |  |
| t <sub>PZLH</sub> | Propagation Delay, MISO Output High<br>Impedance to Active High or Low | External pullup = $5k\Omega$     |    | 16      | ns   |  |
| t <sub>PLHZ</sub> | Propagation Delay, MISO Output Active<br>High or Low to High Impedance | External pullup = $5k\Omega$     |    | 2       | ns   |  |
| t <sub>P</sub>    | Propagation Delay, SPICLK to MISO                                      | External pullup = $5k\Omega$     |    | 20      | ns   |  |

### Table 2S. SPI Interface I/O Voltage Select

| SELSV       | SPI Interface I/O Voltage (SPICLK, MOSI, MISO, nLE, nINT) |  |  |
|-------------|---|--|--|
| 0           | 1.8V  |  |  |
| 1 (default) | 3.3V  |  |  |

# **Register Descriptions**

The Serial Control port of the 8V19N407 supports SPI mode operation. Below indicates how registers may be accessed.

### Table 3A. . Register Map

| Base Address | ster     |   |                      |           |                         |                       |                         |                  |                         |                       |                  |                     |
|--------------|----------|---|----------------------|-----------|-------------------------|-----------------------|-------------------------|------------------|-------------------------|-----------------------|------------------|---------------------|
| e Ac         | Register |   |                      | Default   |                         |                       |                         |                  |                         |                       |                  |                     |
| Bas          | ш        | Register Name   | See                  | Setting   | D7                      | D6                    | D5                      | D4               | D3                      | D2                    | D1               | D0                  |
|              | 0        | QCLKC Control   | Table 3E             | 0000 XXXX | QC<br>DLY[5]            | QC<br>DLY[4]          | QC<br>DLY[3]            | QC<br>DLY[2]     | R/Wn                    | 0                     | 0                | 0                   |
| 0            | 1        | M <sub>V</sub> Feedback<br>Divider Control                  | Table 3C             | 1111 1111 | MV[7]                   | MV[6]                 | MV[5]                   | MV[4]            | MV[3]                   | MV[2]                 | MV[1]            | MV[0]               |
|              | 2        | M <sub>F</sub> Feedback<br>Divider                          | Table 3C             | 0001 0000 | MF[7]                   | MF[6]                 | MF[5]                   | MF[4]            | MF[3]                   | MF[2]                 | MF[1]            | MF[0]               |
|              | З        | SYSREF Control  | Table 3K             | 1000 0001 | Reserved                | Reserved              | Reserved                | Reserved         | Reserved                | Reserved              | Reserved         | SRO                 |
|              | 4        | QCLKC Control<br>QCLKB Control                              | Table 3E             | 0000 XXXX | QC<br>DLY[1]            | QC<br>DLY[0]          | QB<br>DLY[1]            | QB<br>DLY[0]     | R/Wn                    | 0                     | 0                | 1                   |
| 1            | 5        | Reset Control<br>M <sub>V</sub> Feedback<br>Divider Control | Table 3S<br>Table 3C | X000 0000 | SR_REQ0                 | MV[14]                | MV[13]                  | MV[12]           | MV[11]                  | MV[10]                | MV[9]            | MV[8]               |
|              | 6        | QREFA1, A0<br>Control                                       | Table 3G             | 1000 1000 | QREFA1<br><b>A[1]</b>   | QREFA1<br><b>A[0]</b> | QREFA1<br>EF            | QREFA1<br>MUX    | QREFA0<br><b>A[1]</b>   | QREFA0<br><b>A[0]</b> | QREFA0<br>EF     | QREFA0<br>MUX       |
|              | 7        | Reset Control<br>SYSREF Control                             | Table 3S<br>Table 3K | X000 1000 | NR_REQ0                 | Reserved              | SYNC<br>nPOWER          | Reserved         | SYNC<br><b>N[3]</b>     | SYNC<br><b>N[2]</b>   | SYNC<br>N[1]     | SYNC<br><b>N[0]</b> |
|              | 8        | QCLKB Control   | Table 3E             | 0000 XXXX | QB<br>DLY[5]            | QB<br>DLY[4]          | QB<br>DLY[3]            | QB<br>DLY[2]     | R/Wn                    | 0                     | 1                | 0                   |
|              | 9        | P <sub>V</sub> Pre-Divider                                  | Table 3C             | 1111 1111 | PV[7]                   | PV[6]                 | PV[5]                   | PV[4]            | PV[3]                   | PV[2]                 | PV[1]            | PV[0]               |
| 2            | 10       | Status Control  | Table 3O             | XXXX X0XX | Reserved                | STAT2                 | STAT1                   | STAT0            | Reserved                | Reserved              | INT1             | INT0                |
|              | 11       | SYSREF Control<br>QREF B1, B0<br>Control                    | Table 3K<br>Table 3G | 0100 1111 | NS[3]                   | NS[2]                 | NS[1]                   | NS[0]            | QREFB1<br>OE            | QREFB0<br>OE          | QREFA1<br>OE     | QREFA0<br>OE        |
|              | 12       | QCLKA Control   | Table 3E             | 0000 XXXX | QA<br>DLY[5]            | QA<br>DLY[4]          | QA<br>DLY[3]            | QA<br>DLY[2]     | R/Wn                    | 0                     | 1                | 1                   |
| 3            | 13       | VCXO-PLL Control  | Table 3I             | 0010 0000 | POLV                    | HOLD                  | CPV[5]                  | CPV[4]           | CPV[3]                  | CPV[2]                | CPV[1]           | CPV[0]              |
|              | 14       | Reserved  | _                    | 0001 1000 | Reserved                | Reserved              | Reserved                | Reserved         | Reserved                | Reserved              | Reserved         | Reserved            |
|              | 15       | Reserved  | _                    | 1000 0000 | Reserved                | Reserved              | Reserved                | Reserved         | Reserved                | Reserved              | Reserved         | Reserved            |
|              | 16       | QCLKA Control<br>VCXO-PLL Control                           | Table 3E<br>Table 3I | 0000 XXXX | QA<br>DLY[1]            | QA<br>DLY[0]          | Reserved                | BYPASS           | R/Wn                    | 1                     | 0                | 0                   |
| 4            | 17       | QREFA1 Control<br>QREFA0 Control                            | Table 3G             | 0001 0001 | QREFA1<br><b>DLY[2]</b> | QREFA1<br>DLY[1]      | QREFA1<br><b>DLY[0]</b> | QREFA1<br>nPOWER | QREFA0<br>DLY[2]        | QREFA0<br>DLY[1]      | QREFA0<br>DLY[0] | QREFA0<br>nPOWER    |
| -            | 18       | QCLKA Control   | Table 3E             | 0000 0100 | QCLKA<br><b>N[4]</b>    | QCLKA<br>N[3]         | QCLKA<br><b>N[2]</b>    | QCLKA<br>N[1]    | QCLKA<br><b>N[0]</b>    | QA<br>OE              | Ch A<br>nPOWER   | Reserved            |
|              | 19       | QCLKB Control<br>QCLKC Control                              | Table 3E             | 0000 0100 | QCLKB<br>N[4]           | QCLKB<br>N[3]         | QCLKB<br>N[2]           | QCLKB<br>N[1]    | QCLKB<br>N[0]           | QB<br>OE              | Ch B<br>nPOWER   | QCLKC<br>N[0]       |
|              | 20       | QCLKC Control   | Table 3E             | 0000 XXXX | QCLKC<br>N[4]           | QCLKC<br>N[3]         | QCLKC<br>N[2]           | QCLKC<br>N[1]    | R/Wn                    | 1                     | 0                | 1                   |
| 5            | 21       | QREFB1 Control<br>QREFB0 Control                            | Table 3G             | 0001 0001 | QREFB1<br>DLY[2]        | QREFB1<br>DLY[1]      | QREFB1<br>DLY[0]        | QREFB1<br>nPOWER | QREFB0<br><b>DLY[2]</b> | QREFB0<br>DLY[1]      | QREFB0<br>DLY[0] | QREFB0<br>nPOWER    |
|              | 22       | QREFB1 Control<br>QREFB0 Control                            | Table 3G             | 1000 1000 | QREFB1<br><b>A[1]</b>   | QREFB1<br><b>A[0]</b> | QREFB1<br>EF            | QREFB1<br>MUX    | QREFB0<br><b>A[1]</b>   | QREFB0<br><b>A[0]</b> | QREFB0<br>EF     | QREFB0<br>MUX       |
|              | 23       | SYSREF Control  | Table 3K             | 0000 0000 | SRPC[7]                 | SRPC[6]               | SRPC[5]                 | SRPC[4]          | SRPC[3]                 | SRPC[2]               | SRPC[1]          | SRPC[0]             |

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#### Table 3A. . Register Map (Continued)

| <b>Base Address</b> | Register | Register Name                          | See                    | Default<br>Setting | D7            | D6                   | D5                    | D4                    | D3           | D2             | D1                    | D0           |
|---------------------|----------|--|------------------------|--------------------|---------------|----------------------|-----------------------|-----------------------|--------------|----------------|-----------------------|--------------|
|                     | 24       | QCLKC Control                          | Table<br>3ETable<br>3M | 1000 XXXX          | QC<br>OE      | Ch C<br>nPOWER       | Reserved              | SPI_REL               | R/Wn         | 1              | 1                     | 0            |
| 6                   | 25       | Reset Control<br>QCLKB1, B0<br>Control | Table 3S<br>Table 3E   | X010 0100          | SR_REQ1       | Reserved             | QCLKB1<br><b>A[1]</b> | QCLKB1<br><b>A[0]</b> | QCLKB1<br>EF | QCLKB0<br>A[1] | QCLKB0<br><b>A[0]</b> | QCLKB0<br>EF |
|                     | 26       | QCLKA1, A0<br>Control                  | Table 3E               | 0010 0100          | Reserved      | Reserved             | QCLKA1<br><b>A[1]</b> | QCLKA1<br><b>A[0]</b> | QCLKA1<br>EF | QCLKA0<br>A[1] | QCLKA0<br><b>A[0]</b> | QCLKA0<br>EF |
|                     | 27       | Reset Control<br>QVCXO Control         | Table 3S<br>Table 3E   | X100 0001          | NR_REQ1       | QVCXO<br><b>A[1]</b> | QVCXO<br><b>A[0]</b>  | QVCXO<br>EF           | Reserved     | Reserved       | Reserved              | Reserved     |
|                     | 28       | QCLKC Control                          | Table 3E               | 1000 XXXX          | QCLKC<br>A[1] | QCLKC<br>A[0]        | QCLKC<br>EF           | Reserved              | R/Wn         | 1              | 1                     | 1            |
| 7                   | 29       | Reset Control<br>VCO Control           | Table 3S<br>Table 3M   | X000 1010          | SR_RESET      | Reserved             | Reserved              | Reserved              | Reserved     | Reserved       | Reserved              | Reserved     |
|                     | 30       | VCO Control<br>Interrupt Enable        | Table 3M<br>Table 3Q   | 0011 0000          | Reserved      | Reserved             | Reserved              | Reserved              | VCO_SEL      | Reserved       | INTEN1                | INTEN0       |
|                     | 31       | Reset Control                          | Table 3S               | X011 1110          | NR_RESET      | Reserved             | Reserved              | Reserved              | Reserved     | Reserved       | Reserved              | Reserved     |

# **PLL Divider Control Registers**

The divider control registers contains the frequency divider settings for the VCXO-PLL and FemtoClock NG PLL.

#### Table 3B. PLL Divider Control Register Bit Allocations

|          |         | Register Bit |        |        |        |        |       |       |  |  |  |  |  |
|----------|---------|--------------|--------|--------|--------|--------|-------|-------|--|--|--|--|--|
| Register | D7      | D6           | D5     | D4     | D3     | D2     | D1    | D0    |  |  |  |  |  |
| 1        | MV[7]   | MV[6]        | MV[5]  | MV[4]  | MV[3]  | MV[2]  | MV[1] | MV[0] |  |  |  |  |  |
| 2        | MF[7]   | MF[6]        | MF[5]  | MF[4]  | MF[3]  | MF[2]  | MF[1] | MF[0] |  |  |  |  |  |
| 5        | SR_REQ0 | MV[14]       | MV[13] | MV[12] | MV[11] | MV[10] | MV[9] | MV[8] |  |  |  |  |  |
| 9        | PV[7]   | PV[6]        | PV[5]  | PV[4]  | PV[3]  | PV[2]  | PV[1] | PV[0] |  |  |  |  |  |

#### Table 3C. PLL Divider Control Register Function Descriptions

| Bits                  | Name                                  | Factory<br>Default    | Function   |
|-----------------------|---------------------------------------|-----------------------|--|
| M <sub>V</sub> [14:0] | VCXO-PLL Feedback Divider             | 000 0000<br>1111 1111 | VCXO-PLL Feedback Divider. Range: $M_V = \div 4$ to $\div 32767$ . Binary encoding. Default divider: $M_V = \div 255$          |
| P <sub>V</sub> [7:0]  | VCXO-PLL Pre-Divider                  | 1111 1111             | VCXO-PLL Pre Divider. Range: $P_V = \div 1$ to $\div 255$ . Binary encoding. Default divider: $P_V = \div 255$                 |
| M <sub>F</sub> [7:0]  | FemtoClock NG PLL<br>Feedback Divider | 0001 0000             | FemtoClock NG PLL Feedback Divider. Range: $M_F = \div 8$ to $\div 255$ .<br>Binary encoding. Default divider: $M_F = \div 16$ |

# **QCLK, QVCXO Control Registers**

The QCLK, QVCXO Device Clock Output Control Registers contain the settings for the clock frequency divider, phase delay, power state, enable state, signal format and signal amplitude.

|          |               |                      |                       | Registe               | er Bit               |                |                       |                      |
|----------|---------------|----------------------|-----------------------|-----------------------|----------------------|----------------|-----------------------|----------------------|
| Register | D7            | D6                   | D5                    | D4                    | D3                   | D2             | D1                    | D0                   |
| 0        | QC<br>DLY[5]  | QC<br>DLY[4]         | QC<br>DLY[3]          | QC<br>DLY[2]          | R/W                  | 0              | 0                     | 0                    |
| 4        | QC<br>DLY[1]  | QC<br>DLY[0]         | QB<br>DLY[1]          | QB<br>DLY[0]          | R/W                  | 0              | 0                     | 1                    |
| 8        | QB<br>DLY[5]  | QB<br>DLY[4]         | QB<br>DLY[3]          | QB<br>DLY[2]          | R/W                  | 0              | 1                     | 0                    |
| 12       | QA<br>DLY[5]  | QA<br>DLY[4]         | QA<br>DLY[3]          | QA<br>DLY[2]          | R/W                  | 0              | 1                     | 1                    |
| 16       | QA<br>DLY[1]  | QA<br>DLY[0]         | Reserved              | BYPASS                | R/W                  | 1              | 0                     | 0                    |
| 18       | QCLKA<br>N[4] | QCLKA<br>N[3]        | QCLKA<br>N[2]         | QCLKA<br>N[1]         | QCLKA<br><b>N[0]</b> | QA<br>OE       | Ch A<br>nPOWER        | Reserved             |
| 19       | QCLKB<br>N[4] | QCLKB<br>N[3]        | QCLKB<br>N[2]         | QCLKB<br>N[1]         | QCLKB<br><b>N[0]</b> | QB<br>OE       | Ch B<br>nPOWER        | QCLKC<br><b>N[0]</b> |
| 20       | QCLKC<br>N[4] | QCLKC<br>N[3]        | QCLKC<br>N[2]         | QCLKC<br>N[1]         | R/Wn                 | 1              | 0                     | 1                    |
| 24       | QC<br>OE      | Ch C<br>nPOWER       | Reserved              | SPI_REL               | R/Wn                 | 1              | 1                     | 0                    |
| 25       | SR_REQ1       | Reserved             | QCLKB1<br><b>A[1]</b> | QCLKB1<br><b>A[0]</b> | QCLKB1<br>EF         | QCLKB0<br>A[1] | QCLKB0<br><b>A[0]</b> | QCLKB0<br>EF         |
| 26       | Reserved      | Reserved             | QCLKA1<br><b>A[1]</b> | QCLKA1<br><b>A[0]</b> | QCLKA1<br>EF         | QCLKA0<br>A[1] | QCLKA0<br><b>A[0]</b> | QCLKA0<br>EF         |
| 27       | NR_REQ1       | QVCXO<br><b>A[1]</b> | QVCXO<br><b>A[0]</b>  | QVCXO<br>EF           | Reserved             | Reserved       | Reserved              | Reserved             |
| 28       | QCLKC<br>A[1] | QCLKC<br>A[0]        | QCLKC<br>EF           | Reserved              | 0                    | 1              | 1                     | 1                    |

# Table 3E. QCLK, QVCXO Control Register Function Descriptions

| Bits                  | Name                         | Factory<br>Default | Function                                 | Function   |   |   |                          |  |  |  |  |  |  |
|-----------------------|------------------------------|--------------------|--|--|---|---|--------------------------|--|--|--|--|--|--|
|                       |                              |                    | 1 = QCLK                                 | = QCLK <sub>x</sub> output(s) are enabled  |   |   |                          |  |  |  |  |  |  |
| OE                    | QCLK Output<br>Enable        | 1                  | 0 = QCLK                                 | $P = QCLK_x$ output(s) are disabled in the active low state  |   |   |                          |  |  |  |  |  |  |
|                       | Lindbio                      |                    | x denomir                                | nate(s) the  | clock output(s) (e.g                                      | . x = B denominates QCLI                                | KB0 and CLKB1).          |  |  |  |  |  |  |
|                       |                              |                    | 1 = Outpu                                | it channel 2   | X is powered down   |   |                          |  |  |  |  |  |  |
| nPOWER                | Clock Output                 | 0                  | 0 = Outpu                                | 0 = Output channel X is powered up   |   |   |                          |  |  |  |  |  |  |
|                       | Channel Power                |                    |  |  | output channel A, B c<br>, and N <sub>A</sub> for channel | or C. A channel consists o<br>A.                        | f the output divider and |  |  |  |  |  |  |
|                       |                              |                    | These bits                               | s control th   | e value of the clock                                      | frequency divider and out                               | put frequency            |  |  |  |  |  |  |
|                       |                              |                    | N[4                                      | :0]  | Clock Divider   | N[4:0]  | Clock Divider            |  |  |  |  |  |  |
|                       |                              |                    | 000                                      | 000  | ÷2  | 01000   | ÷16                      |  |  |  |  |  |  |
|                       |                              |                    | 000                                      | )01  | ÷3  | 01001   | ÷20                      |  |  |  |  |  |  |
| N <sub>A</sub> [4:0], | Clock Divider Set-<br>ting   |                    | 000                                      | 010  | ÷4  | 01010   | ÷24                      |  |  |  |  |  |  |
| N <sub>B</sub> [4:0], |                              | 00000              | 000                                      | )11  | ÷5  | 01011   | ÷32                      |  |  |  |  |  |  |
| N <sub>C</sub> [4:0]  | ung                          |                    | 00                                       | 100  | ÷6  | 01100   | ÷40                      |  |  |  |  |  |  |
|                       |                              | 000000             | 00                                       | 101  | ÷8  | 01101   | ÷48                      |  |  |  |  |  |  |
|                       |                              |                    | 00                                       | 110  | ÷10   | 01110   | ÷80                      |  |  |  |  |  |  |
|                       |                              |                    | 00111                                    |  | ÷12   | 01111   | ÷96                      |  |  |  |  |  |  |
|                       |                              |                    | 10000                                    |  | ÷1  | 11011   | ÷64                      |  |  |  |  |  |  |
| DLY[5:0]              | Clock Phase<br>Delay         |                    | Φ<br>000000<br>000001<br>000010<br><br>Φ | 000000         0           000001         1/f <sub>VCO</sub> 000010         2· (1/f <sub>VCO</sub> )               |   |   |                          |  |  |  |  |  |  |
| EF                    | QCLK, QVCXO<br>Output Format | 0                  | 0 = LVDS<br>1 = LVPE                     |  | termination across a diffe<br>rmination to the specified  | s a differential pair.<br>pecified recommended termina- |                          |  |  |  |  |  |  |
|                       |                              |                    | QCLK, Q                                  | VCXO am  | plitude control   | Output Termination                                      |                          |  |  |  |  |  |  |
|                       |                              |                    | A[1]                                     | A[0]   | Amplitude   | LVPECL (EF = 1)   | LVDS (EF = 0)            |  |  |  |  |  |  |
| 10.11                 | QCLK,QVCXO                   | 10                 | 0  | 0  | Output is<br>powered- down                                | Should not have any termination                         |                          |  |  |  |  |  |  |
| A[1:0]                | Output Amplitude             | 10                 | 0  | 1  | 400mV   | 50 $\Omega$ to V <sub>DDx</sub> - 1.5V                  | 100Ω across              |  |  |  |  |  |  |
|                       |                              |                    | 1  | 0  | 700mV   | 50 $\Omega$ to V <sub>DDx</sub> - 2V                    | differential pair        |  |  |  |  |  |  |
|                       |                              |                    | -  | 10700mV50Ω to $V_{DDx}$ - 2Vdifferential pair111000mV,<br>f_{OUT} > 500MHz50Ω to $V_{DDx}$ - 2.5Vdifferential pair |   |   |                          |  |  |  |  |  |  |

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# **QREF Output Control Registers**

The QREF Control Registers contain the settings for the SYSREF output enable, power state, signal source and phase delay. Since the registers have an identical format and bit meaning, they are described only once.

|          | Register Bit  |             |               |        |              |              |              |              |  |  |  |
|----------|---------------|-------------|---------------|--------|--------------|--------------|--------------|--------------|--|--|--|
| Register | D7            | D6          | D5            | D4     | D3           | D2           | D1           | D0           |  |  |  |
| 6        | QREFA1        | QREFA1      | QREFA1        | QREFA1 | QREFA0       | QREFA0       | QREFA0       | QREFA0       |  |  |  |
|          | <b>A[1]</b>   | <b>A[0]</b> | EF            | MUX    | <b>A[1]</b>  | <b>A[0]</b>  | EF           | MUX          |  |  |  |
| 11       | NS[3]         | NS[2]       | NS[1]         | NS[0]  | QREFB1<br>OE | QREFB0<br>OE | QREFA1<br>OE | QREFA0<br>OE |  |  |  |
| 17       | QREFA1        | QREFA1      | QREFA1        | QREFA1 | QREFA0       | QREFA0       | QREFA0       | QREFA0       |  |  |  |
|          | <b>DLY[2]</b> | DLY[1]      | <b>DLY[0]</b> | nPOWER | DLY[2]       | DLY[1]       | DLY[0]       | nPOWER       |  |  |  |
| 21       | QREFB1        | QREFB1      | QREFB1        | QREFB0 | QREFB0       | QREFB0       | QREFB0       | QREFB0       |  |  |  |
|          | <b>DLY[2]</b> | DLY[1]      | <b>DLY[0]</b> | nPOWER | DLY[2]       | DLY[1]       | DLY[0]       | nPOWER       |  |  |  |
| 22       | QREFB1        | QREFB1      | QREFB1        | QREFB1 | QREFB0       | QREFB0       | QREFB0       | QREFB0       |  |  |  |
|          | <b>A[1]</b>   | <b>A[0]</b> | EF            | MUX    | <b>A[1]</b>  | <b>A[0]</b>  | EF           | MUX          |  |  |  |

#### Table 3F. QREF Output Control Register Bit Allocations

### Table 3G. QREF Output Control Register Function Descriptions<sup>1</sup>

| Bits     | Name                      | Factory<br>Default | Function   |   |                                      |  |                     |  |  |  |  |
|----------|---------------------------|--------------------|--|---|--------------------------------------|--|---------------------|--|--|--|--|
| MUX      | QREF Signal Source        | 0                  | 1 = QREF   | $1 = QREF_n$ signal source is the QREFn delay circuit (SYSREF mode) |                                      |  |                     |  |  |  |  |
| WIOX     |                           | 0                  | 0 = QREF   | n signal s  | ource is the respect                 | tive N clock divider (Cl               | ock mode)           |  |  |  |  |
| nPOWER   | Output Power              | 1                  | 1 = QREF   | n and dela  | ay block is powered                  | l down                                 |                     |  |  |  |  |
|          |                           | I                  | 0 = QREF   | n and dela  | ay block is powered                  | lup                                    |                     |  |  |  |  |
| DLY[2:0] | SYSREF Phase Delay $\Phi$ | 000                | These bits   | control th  | ne selection of phas                 | e-delay $\Phi$ of the QRE              | F outputs.          |  |  |  |  |
| EF       | QREF Output Format        | 0                  | <ul> <li>Sets the QREF output format:</li> <li>0 = QREF<sub>n</sub> is LVDS (Requires LVDS 100Ω output termination across a differen pair). Use this format for SYSREF or clock signals.</li> <li>1 = QREF<sub>n</sub> is LVPECL (Requires LVPECL 50Ω output termination to the specif recommended termination voltage). Use this format for clock signals.</li> </ul> |   |                                      |  |                     |  |  |  |  |
|          |                           |                    | QREFn A  | mplitude  | Control                              | Output Termination                     |                     |  |  |  |  |
|          |                           |                    | A[1]   | A[0]  | QREF<br>Amplitude                    | LVPECL (EF = 1)                        | LVDS (EF = 0)       |  |  |  |  |
| A[1:0]   | QREF Output Amplitude     | 10                 | 0  | 0   | Powered-down                         | Should not have any termination        |                     |  |  |  |  |
|          |                           |                    | 0  | 1   | 400mV                                | 50 $\Omega$ to V <sub>DDx</sub> - 1.5V | 100 $\Omega$ across |  |  |  |  |
|          |                           |                    | 1  | 0   | 700mV                                | 50 $\Omega$ to V <sub>DDx</sub> - 2V   | differential pair   |  |  |  |  |
|          |                           |                    | 1  | 1   | 1000mV,<br>f <sub>OUT</sub> > 500MHz | 50 $\Omega$ to $V_{DDx}$ - 2.5V        |                     |  |  |  |  |
| OE       | QREF Enable               | 1                  | 1 = QREF   | n output is   | enabled                              |  |                     |  |  |  |  |
|          |                           |                    | 0 = QREF   | <sub>n</sub> output is  | s disabled in the act                | tive low state                         |                     |  |  |  |  |

NOTE 1. Subscript "n" represents the output number.

# **VCXO-PLL Control Registers**

The device control register contains settings for the VCXO-PLL charge pump and VCXO control voltage polarity and VCXO-bypass.

|          |              | Register Bit |          |        |        |        |        |        |  |  |  |  |  |
|----------|--------------|--------------|----------|--------|--------|--------|--------|--------|--|--|--|--|--|
| Register | D7           | D6           | D5       | D4     | D3     | D2     | D1     | D0     |  |  |  |  |  |
| 13       | POLV         | HOLD         | CPV[5]   | CPV[4] | CPV[3] | CPV[2] | CPV[1] | CPV[0] |  |  |  |  |  |
| 16       | QA<br>DLY[1] | QA<br>DLY[0] | Reserved | BYPASS | R/Wn   | 1      | 0      | 0      |  |  |  |  |  |

#### Table 3H. VCXO-PLL Control Register Bit Allocations

#### Table 3I. VCXO-PLL Control Register Function Descriptions

| Bits     | Name                            | Factory<br>Default | Function   |
|----------|---------------------------------|--------------------|--|
| CPV[5:0] | VCXO-PLL Charge-Pump<br>Current | 10 0000            | Controls the charge pump current of the VCXO-PLL. Charge pump current is the binary value of this register multiplied by $20\mu$ A.<br>ICP = $20\mu$ A · CPV[5:0]. Default setting is $640\mu$ A ( $32 \cdot 20\mu$ A)           |
| POLV     | VCXO Polarity                   | 0                  | <ul> <li>0 = Positive polarity. Use for an external VCXO with a positive f(V<sub>C</sub>) characteristics.</li> <li>1 = Negative polarity. Use for an external VCXO with a negative f(V<sub>C</sub>) characteristics.</li> </ul> |
| HOLD     | Holdover Control                | 0                  | <ul> <li>0 = Normal operation</li> <li>1 = VCXO-PLL is set to holdover. The control voltage of the external VCXO is set to V<sub>DD</sub>/2.</li> </ul>  |
| BYPASS   | VCXO-PLL Bypass                 | 0                  | 0 = VCXO-PLL is enabled<br>1 = VCXO-PLL is bypassed  |

## **SYSREF Control Registers**

The SYSREF pulse count register (SRPC) contains the binary setting for the number of SYSREF pulses generated by the device.

#### Table 3J. SYSREF Control Register Bit Allocations

|          |                   | Register Bit |                |             |                     |                     |              |                     |  |  |  |  |
|----------|-------------------|--------------|----------------|-------------|---------------------|---------------------|--------------|---------------------|--|--|--|--|
| Register | D7                | D6           | D5             | D4          | D3                  | D2                  | D1           | D0                  |  |  |  |  |
| 3        | VCO_DIV<br>nPOWER | VCO<br>N[3]  | VCO<br>N[2]    | VCO<br>N[1] | VCO<br>N[0]         | VCO<br>nPOWER       | Reserved     | SRO                 |  |  |  |  |
| 7        | NR_REQ0           | Reserved     | SYNC<br>nPOWER | Reserved    | SYNC<br><b>N[3]</b> | SYNC<br><b>N[2]</b> | SYNC<br>N[1] | SYNC<br><b>N[0]</b> |  |  |  |  |
| 11       | NS[3]             | NS[2]        | NS[1]          | NS[0]       | QREFB1<br>OE        | QREFB0<br>OE        | QREFA1<br>OE | QREFA0<br>OE        |  |  |  |  |
| 23       | SRPC[7]           | SRPC[6]      | SRPC[5]        | SRPC[4]     | SRPC[3]             | SRPC[2]             | SRPC[1]      | SRPC[0]             |  |  |  |  |

# Table 3K. SYSREF Control Register Function Descriptions

| Bits           | Name                          | Factory<br>Default | Function   |            |      |     |                          |  |
|----------------|-------------------------------|--------------------|--|------------|------|-----|--------------------------|--|
| SRPC[7:0]      | SYSREF Pulse<br>Count         | 0000 0000          | Binary value of the SYSREF pulses generated by the 8V19N407 and output at all en-<br>abled QREF outputs. Allows to generate 1 to 255 pulses after each write access. Re-<br>quires SRO = 0. The programmed number of SYSREF pulses is generated after the<br>SYSREF synchronization procedure completes. See Section, "SYSREF Generation" on<br>page 12. |            |      |     |                          |  |
|                |                               |                    | SYSREF   | Divider Va | alue |     |                          |  |
|                |                               |                    | NS3  | NS2        | NS1  | NS0 | Value                    |  |
|                |                               |                    | 0  | 0          | 0    | 0   | ÷64                      |  |
|                |                               |                    | 0  | 0          | 0    | 1   | ÷96                      |  |
|                |                               |                    | 0  | 0          | 1    | 0   | ÷128                     |  |
|                |                               |                    | 0  | 0          | 1    | 1   | ÷192                     |  |
| NS[3:0]        | SYSREF<br>Frequency Divider   | 0100               | 0  | 1          | 0    | 0   | ÷256                     |  |
|                |                               |                    | 0  | 1          | 0    | 1   | ÷384                     |  |
|                |                               |                    | 0  | 1          | 1    | 0   | ÷512                     |  |
|                |                               |                    | 0  | 1          | 1    | 1   | ÷768                     |  |
|                |                               |                    | 1  | 0          | 0    | 0   | ÷1024                    |  |
|                |                               |                    | 1  | 0          | 0    | 1   | ÷2048                    |  |
|                |                               |                    | 1  | 0          | Х    | Х   | 1010-1111 are undefined. |  |
| SYNC<br>nPOWER | Synchronizer Power<br>Control | 0                  | <ul> <li>0 = SYSREF synchronizer power up</li> <li>1 = SYSREF synchronizer power down</li> <li>Power down the SYSREF synchronizer if all QREFn outputs are used as clock output</li> </ul>   |            |      |     |                          |  |

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#### Table 3K. SYSREF Control Register Function Descriptions (Continued)

| Bits   | Name                   | Factory<br>Default | Function  |   |       |       |       |  |  |  |
|--------|------------------------|--------------------|---|---|-------|-------|-------|--|--|--|
|        |                        |                    | es at coin<br>vider valu  | SYSREF Synchronizer divider value. This divider controls the release of SYSREF pulses at coincident QCLKAn and QCLKBn clock edges. For SYSREF operation, set this divider value to the least common multiple of the clock divider values $N_A$ and $N_B$ . For instance, if $N_A = \pm 2$ and $N_B = \pm 3$ , set the SYNC divider to $\pm 6$ (SYNC[3:0] = 0100). |       |       |       |  |  |  |
|        |                        |                    | SYNC3   | SYNC2   | SYNC1 | SYNC0 | Value |  |  |  |
|        |                        |                    | 0   | 0   | 0     | 0     | ÷2    |  |  |  |
|        |                        |                    | 0   | 0   | 0     | 1     | ÷3    |  |  |  |
|        |                        |                    | 0   | 0   | 1     | 0     | ÷4    |  |  |  |
|        |                        | 1000               | 0   | 0   | 1     | 1     | ÷5    |  |  |  |
|        | 000055                 |                    | 0   | 1   | 0     | 0     | ÷6    |  |  |  |
| SYNC   | SYSREF<br>Synchronizer |                    | 0   | 1   | 0     | 1     | ÷8    |  |  |  |
| N[3:0] | Divider                |                    | 0   | 1   | 1     | 0     | ÷10   |  |  |  |
|        |                        |                    | 0   | 1   | 1     | 1     | ÷12   |  |  |  |
|        |                        |                    | 1   | 0   | 0     | 0     | ÷16   |  |  |  |
|        |                        |                    | 1   | 0   | 0     | 1     | ÷20   |  |  |  |
|        |                        |                    | 1   | 0   | 1     | 0     | ÷24   |  |  |  |
|        |                        |                    | 1   | 0   | 1     | 1     | ÷32   |  |  |  |
|        |                        |                    | 1   | 1   | 0     | 0     | ÷40   |  |  |  |
|        |                        |                    | 1   | 1   | 0     | 1     | ÷48   |  |  |  |
|        |                        |                    | 1   | 1   | 1     | 0     | ÷80   |  |  |  |
|        |                        |                    | 1   | 1   | 1     | 1     | ÷96   |  |  |  |
| SRO    | SYSREF Operation       | 1                  | <ul> <li>0 = Single SYSREF pulse generation mode.<br/>Number of pulses is controlled by SRPC[7:0].</li> <li>1 = Continuous SYSREF pulse generation</li> </ul> |   |       |       |       |  |  |  |

## FemtoClock NG PLL Control Registers

The FemtoClock NG registers contain the setting for the divider, selection and power state.

#### Table 3L. FemtoClockNG PLL Control Register Bit Allocations

|          | Register Bit |                |          |          |         |          |        |        |
|----------|--------------|----------------|----------|----------|---------|----------|--------|--------|
| Register | D7           | D6             | D5       | D4       | D3      | D2       | D1     | D0     |
| 24       | QC<br>OE     | Ch C<br>nPOWER | Reserved | SPI_REL  | R/Wn    | 1        | 1      | 0      |
| 30       | Reserved     | Reserved       | Reserved | Reserved | VCO_SEL | Reserved | INTEN1 | INTEN0 |

#### Table 3M. FemtoClockNG PLL Control Register Function Descriptions

| Bits    | Name                     | Factory<br>Default | Function   |
|---------|--------------------------|--------------------|--|
| VCO_SEL | VCO Frequency Select     | 0                  | This bit must be set '0'   |
| SPI_REL | FemtoClock NG PLL Relock | 0                  | 0 = no effect<br>1 = Creates a pulse that forces a re-lock on the FemtoClock NG PLL. Bit au-<br>to-clears. (Any changes of VCO-PLL parameters, such as Feedback Divider $M_F$<br>requires re-locking using SPI_REL bit.) |

# **Status Registers**

This register contains the clock status bits STAT[2:0] and latched copies of these bits (INT[1:0]).

## Table 3N. Status Register Bit Allocations

|          | Register Bit |       |       |       |    |          |      |      |
|----------|--------------|-------|-------|-------|----|----------|------|------|
| Register | D7           | D6    | D5    | D4    | D3 | D2       | D1   | D0   |
| 10       |              | STAT2 | STAT1 | STAT0 |    | Reserved | INT1 | INT0 |

### Table 30. Status Register Function Descriptions

| Bits     | Name  | Factory<br>Default | Function   |
|----------|---|--------------------|--|
| STAT2    | VCO Calibration                             | _                  | VCO calibration status:<br>1 = Completed   |
| 01/12    | VOO Galibration                             |                    | 0 = Not completed  |
|          |   |                    | VCXO-PLL (1st stage) lock status:  |
| STAT1    | VCXO-PLL Lock Status                        | -                  | 1 = VCXO-PLL is locked   |
|          |   |                    | 0 = VCXO-PLL is unlocked   |
|          |   |                    | CLK Input clock status:  |
| STAT0    | Clock Input CLK Status                      | -                  | 1 = CLK input clock is present   |
|          |   |                    | 0 = CLK input clock not detected   |
| INT[1:0] | Individual Interrupt Status &<br>Clear Bits | -                  | These bits contain a latched version of the STAT[1:0] bits: The INT[1:0] bits indicate a fault condition (0) since the last interrupt clear command. Writing a 1 to a INT[1:0] bit position will clear that interrupt latch, provided the corresponding fault condition has also been cleared. Clearing the latch with the corresponding STAT[1:0] bit still indicating a fault (0) will result in an immediate re-trigger of the latch. |

# Interrupt Enable Register

This register controls the interrupt functions of the 8V19N407.

## Table 3P. Interrupt Enable Register Bit Allocations

|          | Register Bit |          |          |          |     |          |        |        |
|----------|--------------|----------|----------|----------|-----|----------|--------|--------|
| Register | D7           | D6       | D5       | D4       | D3  | D2       | D1     | D0     |
| 30       | Reserved     | Reserved | Reserved | Reserved | SEL | Reserved | INTEN1 | INTEN0 |

## Table 3Q. Interrupt Enable Register Function Descriptions

| Bits       | Name                  | Factory<br>Default | Function  |
|------------|-----------------------|--------------------|---|
| INTEN[1:0] | Interrupt Enable Bits | 00                 | A setting of 0 in any of these bit positions will mask the corresponding INT[1:0] latch bit from affecting the interrupt output signal (nINT). A setting of 1 in any bit position will enable that INT[1:0] latch bit to drive the interrupt signal nINT. Setting all INTEN[1:0] to 0 has the effect of disabling interrupts from the device. |

## **Reset Control Registers**

The Reset Control Registers contain the settings for the register controlled-reset and restart capabilities of the device. Output divider reset (NR\_REQ0, NR\_REQ1, NR\_RESET): the divider reset sequence is required after device startup and after any N divider value change. See Section, "Clock Output Divider Reset Sequence, (Sequence S1)" on page 14.

The QREF phase delay and SYSREF synchronization sequence is required for the synchronization of the delay stages after each delay stage configuration, and is also applicable for the generation of SYSREF pulses. Sequence: write a logic 1 to SR\_REQ0, SR\_REQ1 and SR\_RESET in this order to generate a programmable number of SYSREF pulses at all enabled QREF outputs. See Section, "QREF Phase Delay and SYSREF Synchronization Sequence, (Sequence S2)" on page 14.

|          |          | Register Bit  |                |                |              |                |                |              |  |  |  |  |
|----------|----------|---------------|----------------|----------------|--------------|----------------|----------------|--------------|--|--|--|--|
| Register | D7       | D6            | D5             | D4             | D3           | D2             | D1             | D0           |  |  |  |  |
| 5        | SR_REQ0  | MV[14]        | MV[13]         | MV[12]         | MV[11]       | MV[10]         | MV[9]          | MV[8]        |  |  |  |  |
| 7        | NR_REQ0  | Reserved      | SYNC<br>nPOWER | Reserved       | SYNC<br>N[3] | SYNC<br>N[2]   | SYNC<br>N[1]   | SYNC<br>N[0] |  |  |  |  |
| 25       | SR_REQ1  | Reserved      | QCLKB1<br>A[1] | QCLKB1<br>A[0] | QCLKB1<br>EF | QCLKB0<br>A[1] | QCLKB0<br>A[0] | QCLKB0<br>EF |  |  |  |  |
| 27       | NR_REQ1  | QVCXO<br>A[1] | QVCXO<br>A[0]  | QVCXO<br>EF    | Reserved     | Reserved       | Reserved       | Reserved     |  |  |  |  |
| 29       | SR_RESET | Reserved      | Reserved       | Reserved       | Reserved     | Reserved       | Reserved       | Reserved     |  |  |  |  |
| 31       | NR_RESET | Reserved      | Reserved       | Reserved       | Reserved     | Reserved       | Reserved       | VCO_FSEL     |  |  |  |  |

#### Table 3R. Reset Control Register Bit Allocations

| Bits     | Name   | Factory<br>Default | Function   |
|----------|--|--------------------|--|
| NR_REQ0  | N <sub>A,</sub> N <sub>B,</sub> N <sub>C</sub> Output Divider<br>Reset Request 0 <sup>1</sup> , Auto-clear | х                  | Writing a 1 to the bit position D7 in register 7 is the first step of the reset/re-synchronization sequence for the frequency dividers $N_{A-C}$ . All QCLK outputs are set to the logic low stage. This bit auto-clears after the reset sequence. Writing a 0 to this bit position has no effect.   |
| NR_REQ1  | N <sub>A,</sub> N <sub>B,</sub> N <sub>C</sub> Output Divider<br>Reset Request 1, Auto-clear               | Х                  | Writing a 1 to the bit position D7 in register 29 is the second step of the reset/re-synchronization sequence for the frequency dividers $N_{A-C}$ . After this bit is set to logic 1, the dividers $N_{A-C}$ can be reset synchronously by writing a logic 1 to the NR_RESET bit (register 31, bit position D7) Independent on the selected output dividers $N_{A-C}$ , the QCLK outputs will then restart with a rising edge simultaneously. |
|          |  |                    | This bit clears itself after the completion of the reset sequence and QCLK[A-C] outputs are reset. Writing a 0 to this bit position has no effect.   |
| NR_RESET | N <sub>A,</sub> N <sub>B,</sub> N <sub>C</sub> Output Divider<br>Divider Reset Auto-clear                  | х                  | Writing a 1 to the bit position D7 in register 31 is the third and final step of the reset/re-synchronization sequence for the frequency dividers $N_{A-C}$ . The dividers re-start synchronously up to 10 clock periods after this reset bit is written. This bit clears itself after the completion of the reset sequence and QCLK[A-C] outputs are reset. Writing a 0 to this bit position has no effect.                                   |
| SR_REQ0  | SYSREF Synchronization<br>Request 0 <sup>2</sup> , Auto-clear  | Х                  | Writing a 1 to the bit position D7 in register 5 is the first step of the synchronization sequence for the SYSREF outputs (QREF). This bit auto-clears after the reset sequence. Writing a 0 to this bit position has no effect. Requires SRO = 0, otherwise no function.  |
| SR_REQ1  | SYSREF Synchronization<br>Request 1, Auto-clear  | х                  | Writing a 1 to the bit position D7 in register 27 is the second step of the synchronization sequence for the SYSREF outputs (QREF). The N <sub>S</sub> divider is reset. The SYSREF outputs (QREF) are active and set to logic low level in preparation to the last step (SR_RESET). Requires SRO = 0, otherwise no function.  |
|          |  |                    | This bit clears itself after the completion of the reset sequence and QREF outputs are reset. Writing a 0 to this bit position has no effect.  |
|          |  |                    | Writing a 1 to the bit position D7 in register 29 is the third and final step of the synchronization sequence for the SYSREF outputs (QREF).   |
| SR_RESET | SYSREF Synchronization<br>Reset Auto-clear   | х                  | After writing a 1 to SR_RESET, the number of SYSREF pulses programmed in SRPC[7:0] are synchronously output at all enabled QREF outputs.   |
|          | neset Auto-clear   |                    | This bit clears itself after the completion of the synchronization sequence. Writing a 0 to this bit position has no effect. Requires $SRO = 0$ , otherwise no function.   |

NOTE 1. See Section, "Clock Output Divider Reset Sequence, (Sequence S1)" on page 14.

NOTE 2. See Section, "QREF Phase Delay and SYSREF Synchronization Sequence, (Sequence S2)" on page 14.

# **Absolute Maximum Ratings**

NOTE: Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These ratings are stress specifications only. Functional operation of product at these conditions or any conditions beyond those listed in the *DC Characteristics or AC Characteristics* is not implied. Exposure to absolute maximum rating conditions for extended periods may affect product reliability.

#### Table 4A. Absolute Maximum Ratings

| Item  | Rating                           |
|---|----------------------------------|
| Supply Voltage, V <sub>DDx</sub>  | 4.6V                             |
| Inputs  | -0.5V to V <sub>DDx</sub> + 0.5V |
| Outputs, V <sub>O</sub> (LVCMOS)  | -0.5V to V <sub>DDx</sub> + 0.5V |
| Outputs, I <sub>O</sub> (LVPECL)<br>Continuous Current<br>Surge Current | 50mA<br>100mA                    |
| Outputs, I <sub>O</sub> (LVDS)<br>Continuous Current<br>Surge Current   | 10mA<br>15mA                     |
| Junction Temperature, T <sub>J</sub>                                    | 125°C                            |
| Storage Temperature, T <sub>STG</sub>                                   | -65°C to 150°C                   |

#### Table 4B. Pin Characteristics

| Symbol                | Parameter            |                      | Test Conditions  | Minimum          | Typical | Maximum | Units |   |
|-----------------------|----------------------|----------------------|------------------|------------------|---------|---------|-------|---|
| C <sub>IN</sub>       | Input<br>Capacitance | nLE, MOSI,<br>SPICLK |                  |                  | 4       |         | pF    |   |
| R <sub>PULLUP</sub>   | Input Pullup F       | Resistor             |                  |                  | 51      |         | kΩ    |   |
| R <sub>PULLDOWN</sub> | Input Pulldow        | n Resistor           |                  |                  | 51      |         | kΩ    |   |
| R <sub>OUT</sub>      | Output<br>Impedance  | MISO INT             | MISO INT         | SELSV = 1 (3.3V) |         | 30      |       | Ω |
|                       |                      |                      | SELSV = 0 (1.8V) |                  | 40      |         | Ω     |   |

# **DC Electrical Characteristics**

# Table 5A. Power Supply DC Characteristics, $V_{DDx} = V_{DDQx} = 3.3V \pm 5\%$ , $T_A = -40^{\circ}C$ to $+85^{\circ}C^{1, 2, 3, 4}$

| Symbol            | Parameter  | Test Conditions  | Minimum | Typical | Maximum | Units |
|-------------------|--|--|---------|---------|---------|-------|
| V <sub>DDx</sub>  | Power Supply Voltage                             |  | 3.135   | 3.3     | 3.465   | V     |
| V <sub>DDQx</sub> | Output Supply Voltage                            |  | 3.135   | 3.3     | 3.465   | V     |
| 1                 | Power Supply Current <sup>5</sup>                | LVPECL Output Setting                                  |         | 325     | 350     | mA    |
| IDDx              |  | LVDS Output Setting                                    |         | 355     | 370     | mA    |
|                   | Output Supply Current,<br>LVPECL <sup>5, 6</sup> | 400mV Amplitude Setting                                |         | 300     | 400     | mA    |
|                   |  | 700mV Amplitude Setting                                |         | 315     | 420     | mA    |
| 1                 |  | 1000mV Amplitude Setting,<br>f <sub>OUT</sub> > 500MHz |         | 354     | 460     | mA    |
| DDQx              |  | 400mV Amplitude Setting                                |         | 452     | 550     | mA    |
|                   | Output Supply Current,                           | 700mV Amplitude Setting                                |         | 522     | 620     | mA    |
|                   | LVDS <sup>5, 7</sup>                             | 1000mV Amplitude Setting,<br>f <sub>OUT</sub> > 500MHz |         | 617     | 670     | mA    |

NOTE 1. V<sub>DDx</sub> denotes V<sub>DD1</sub>, V<sub>DD2</sub>, V<sub>DD3</sub>, V<sub>DD4</sub>, V<sub>DD5</sub>, V<sub>DD6</sub>, V<sub>DD7</sub>.

NOTE 2. V<sub>DDQx</sub> denotes V<sub>DDQA</sub>, V<sub>DDQB</sub>, V<sub>DDQC</sub>.

NOTE 3.  $I_{DDx}$  denotes  $I_{DD1}$ ,  $I_{DD2}$ ,  $I_{DD3}$ ,  $I_{DD4}$ ,  $I_{DD5}$ ,  $I_{DD6}$ ,  $I_{DD7}$ .

NOTE 4. I<sub>DDQx</sub> denotes I<sub>DDQA</sub>, I<sub>DDQB</sub>, I<sub>DDQC</sub>.

NOTE 5. Both VCXO-PLL and FemtoClock NG PLL are locked and all output clocks are running (QREFn are in QCLK mode). SYSREF delay stages and synchronizer control are disabled.

NOTE 6. Outputs not terminated.

NOTE 7. Outputs not terminated with 100  $\!\Omega$  across the differential pair.

# Table 5B. LVCMOS/LVTTL DC Characteristics, $V_{DDx} = V_{DDQx} = 3.3V \pm 5\%$ , $T_A = -40^{\circ}$ C to $+85^{\circ}$ C<sup>1, 2</sup>

| Symbol          | Parameter              |                   | Test Conditions                                    | Minimum  | Typical | Maximum          | Units |   |
|-----------------|------------------------|-------------------|--|--|---------|------------------|-------|---|
|                 |                        |                   | SELSV = 0  | 1.3  |         | 1.8              | V     |   |
| V <sub>IH</sub> | Input High Volt        | age               | SELSV = 1  | 2.3  |         | V <sub>DDX</sub> | V     |   |
| V               |                        |                   | SELSV = 0  | -0.3   |         | 0.35             | V     |   |
| V <sub>IL</sub> | Input Low Volta        | age               | SELSV = 1  | -0.3   |         | 0.6              | V     |   |
| 1               | Input                  | SPICLK, nLE, MOSI | $V_{DD5} = 3.3V, V_{IN} = 3.3V$                    |  |         | 150              | μA    |   |
| Ιн              | High Current           | SELSV             | $V_{DD5} = 3.3V, V_{IN} = 3.3V$                    |  |         | 5                | μA    |   |
| 1               | Input<br>Low Current   | SPICLK, nLE, MOSI | V <sub>DD5</sub> = 3.465V, V <sub>IN</sub> = 0V    | -5   |         |                  | μA    |   |
| IIL             |                        | SELSV             | V <sub>DD5</sub> = 3.465V, V <sub>IN</sub> = 0V    | -150   |         |                  | μA    |   |
| V <sub>OH</sub> | Output<br>High Voltage | Output            | nINT, MISO   | $V_{DDQx} = 3.465V$ , SELSV = 0<br>$I_{OH} = -2mA$ | 1.65    |                  |       | V |
|                 |                        |                   | $V_{DDQx} = 3.465V$ , SELSV = 1<br>$I_{OH} = -4mA$ | 2.0  |         |                  | V     |   |
| V <sub>OL</sub> | Output<br>Low Voltage  | Output            | nINT, MISO   | $V_{DDQx} = 3.465V$ , SELSV = 0<br>$I_{OL} = 2mA$  |         |                  | 0.15  | V |
|                 |                        |                   | $V_{DDQx} = 3.465V$ , SELSV = 1<br>$I_{OL} = 4mA$  |  |         | 0.5              | v     |   |

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NOTE 1.  $V_{DDx}$  denotes:  $V_{DD1},\,V_{DD2},\,V_{DD3},\,V_{DD4},\,V_{DD5},\,V_{DD6}$  and  $V_{DD7.}$ 

NOTE 2. V<sub>DDQx</sub> denotes V<sub>DDQA</sub>, V<sub>DDQB</sub>, V<sub>DDQC</sub>.

| Symbol | Parameter             |                           | Test Conditions                                 | Minimum | Typical | Maximum | Units |
|--------|-----------------------|---------------------------|---|---------|---------|---------|-------|
| IIH    | Input<br>High Current | CLK, nCLK,<br>VCXO, nVCXO | $V_{DD5} = V_{IN} = 3.465V$                     |         |         | 150     | μΑ    |
| I.,    | Input                 | CLK, VCXO                 | V <sub>DD5</sub> = 3.465V, V <sub>IN</sub> = 0V | -5      |         |         | μA    |
| ΊL     | Low Current           | nCLK, nVCXO               | V <sub>DD5</sub> = 3.465V, V <sub>IN</sub> = 0V | -150    |         |         | μA    |

#### Table 5C. Differential Input DC Characteristics, $V_{DD5}$ = 3.3V ± 5%, $T_A$ = -40°C to +85°C

#### Table 5D. LVPECL DC Characteristics (QCLKn, EF = 1), $V_{DDQx} = 3.3V \pm 5\%$ , GND = 0V, $T_A = -40^{\circ}$ C to $+85^{\circ}$ C<sup>1</sup>

| Symbol          | Parameter                        | Test Conditions                                       | Minimum                   | Typical                 | Maximum                  | Units |
|-----------------|----------------------------------|---|---------------------------|-------------------------|--------------------------|-------|
|                 |                                  | 400mV Amplitude Setting                               |                           |                         |                          |       |
| V <sub>OH</sub> | Output High Voltage <sup>2</sup> | 700mV Amplitude Setting                               | V <sub>DDQX</sub> – 1.41  | V <sub>DDQX</sub> – 0.9 | V <sub>DDQX</sub> – 0.55 | v     |
|                 |                                  | 1000mV Amplitude Setting,<br>f <sub>OUT</sub> >500MHz |                           | PDDQX 0.0               | UDDQX 0.00               |       |
|                 |                                  | 400mV Amplitude Setting                               | V <sub>DDQX</sub> – 1.66  | V <sub>DDQX</sub> – 1.3 | V <sub>DDQX</sub> – 1.11 | V     |
| V <sub>OL</sub> | Output Low Voltage <sup>2</sup>  | 700mV Amplitude Setting                               | V <sub>DDQX</sub> – 1.965 | V <sub>DDQX</sub> – 1.6 | V <sub>DDQX</sub> – 1.35 | V     |
| * OL            | - and a controllage              | 1000mV Amplitude Setting,<br>f <sub>OUT</sub> >500MHz | V <sub>DDQX</sub> – 2.22  | V <sub>DDQX</sub> – 2.0 | V <sub>DDQX</sub> – 1.5  | V     |

NOTE 1. V<sub>DDQx</sub> denotes: V<sub>DDQA</sub>, V<sub>DDQB</sub>, V<sub>DDQC</sub>.

NOTE 2. Outputs terminated with 50 $\Omega$  to V<sub>DDQx</sub> – 1.5V (400mV amplitude setting), V<sub>DDQx</sub> – 2.0V (700mV amplitude setting), V<sub>DDQx</sub> – 2.5V (1000mV amplitude setting).

#### Table 5E. LVDS DC Characteristics (QCLKn, EF = 0), $V_{DDQx}$ = 3.3V ± 5%, GND = 0V, $T_A$ = -40°C to +85°C<sup>1</sup>

| Symbol          | Parameter                        | Test Conditions                                       | Minimum | Typical | Maximum | Units |
|-----------------|----------------------------------|---|---------|---------|---------|-------|
| V <sub>OS</sub> | Offset Voltage <sup>2</sup>      | 400mV Amplitude Setting                               |         | 2.3     |         | V     |
|                 |                                  | 700mV Amplitude Setting                               |         | 2.1     |         | V     |
|                 |                                  | 1000mV Amplitude Setting,<br>f <sub>OUT</sub> >500MHz |         | 1.9     |         | V     |
| $\Delta V_{OS}$ | V <sub>OS</sub> Magnitude Change |   |         | 20      |         | mV    |

NOTE 1. V<sub>DDQx</sub> denotes V<sub>DDQA</sub>, V<sub>DDQB</sub>, V<sub>DDQC</sub>.

NOTE 2.  $V_{OS}$  changes with  $V_{DD}$ 

#### Table 5F. LVDS DC Characteristics (QREFn), $V_{DDQx} = 3.3V \pm 5\%$ , GND = 0V, $T_A = -40^{\circ}$ C to +85°C<sup>1</sup>

| Symbol          | Parameter                        | Test Conditions                                       | Minimum | Typical | Maximum | Units |
|-----------------|----------------------------------|---|---------|---------|---------|-------|
| V <sub>OS</sub> | Offset Voltage <sup>2</sup>      | 400mV Amplitude Setting                               |         | 2.3     |         | V     |
|                 |                                  | 700mV Amplitude Setting                               |         | 2.1     |         | V     |
|                 |                                  | 1000mV Amplitude Setting,<br>f <sub>OUT</sub> >500MHz |         | 1.9     |         | V     |
| $\Delta V_{OS}$ | V <sub>OS</sub> Magnitude Change |   |         | 20      |         | mV    |

NOTE 1.  $V_{DDQX}$  denotes  $V_{DDQA}$ ,  $V_{DDQB}$ ,  $V_{DDQC}$ .

NOTE 2.  $V_{\mbox{OS}}$  changes with  $V_{\mbox{DD.}}$ 

# **AC Electrical Characteristics**

# Table 6A. AC Characteristics, $V_{DDx} = V_{DDQx} = 3.3V \pm 5\%$ , GND = 0V, $T_A = -40^{\circ}C$ to +85°C <sup>1</sup>

| Symbol                          | Parameter  |                           | Test Conditions                                      | Minimum               | Typical | Maximum               | Units  |
|---------------------------------|--|---------------------------|--|-----------------------|---------|-----------------------|--|
| £                               |  | Danga                     | 8V19N407-19  | 1900                  |         | 2000                  | MHz  |
| f <sub>VCO</sub>                | VCO Frequency  | naliye                    | 8V19N407-24  | 2400                  |         | 2500                  |  |
|                                 |  |                           | 400mV Amplitude Setting                              | f <sub>VCO</sub> ÷ 96 |         |                       |  |
|                                 |  | QCLKx                     | 700mV Amplitude Setting                              | f <sub>VCO</sub> ÷ 96 |         | f <sub>VCO</sub>      | MHz  |
| £                               | Output   |                           | 1000mV Amplitude Setting                             | 500                   |         | _                     |  |
| fout                            | Frequency <sup>2</sup>   |                           | 400mV Amplitude Setting                              | f <sub>VCO</sub> ÷ 96 |         |                       |  |
|                                 |  | QREFx                     | 700mV Amplitude Setting                              | f <sub>VCO</sub> ÷ 96 |         | f <sub>VCO</sub>      | MHz<br>MHz<br>V<br>V<br>V<br>V<br>MV<br>mV<br>mV<br>MV<br>MV<br>MV<br>MV<br>MV<br>MV<br>MV<br>S<br>S<br>S<br>S<br>S<br>S<br>S<br>S<br>S      |
|                                 |  |                           | 1000mV Amplitude Setting                             | 500                   |         | _                     |  |
| V <sub>PP</sub>                 | Peak-to-peak<br>Input Voltage <sup>3</sup>   | CLK, nCLK                 |  | 0.2                   |         | 1.4                   | V  |
| V <sub>CMR</sub>                | Common Mode I  | nput Voltage <sup>4</sup> |  | 1.1                   |         | V <sub>DD</sub> – 0.3 | V  |
|                                 |  |                           | 400mV Amplitude Setting                              | 310                   | 425     | 570                   | mV   |
|                                 |  |                           | 700mV Amplitude Setting                              | 500                   | 730     | 1020                  | mV   |
| v 5                             |  | Jour                      | 1000mV Amplitude Setting                             | 870                   | 1080    | 1200                  | MHz<br>MHz<br>MHz<br>MHz<br>MHz<br>V<br>V<br>V<br>V<br>V<br>WV<br>mV<br>mV<br>mV<br>mV<br>mV<br>mV<br>mV<br>mV<br>mV<br>mV<br>mV<br>mV<br>mV |
| V <sub>O(PP)</sub> <sup>5</sup> |  |                           | 400mV Amplitude Setting                              | 620                   | 850     | 1140                  |  |
|                                 |  |                           | 700mV Amplitude Setting                              | 1000                  | 1460    | 2040                  | mV   |
|                                 | Voltage Owing, I   | can to peak               | 1000mV Amplitude Setting                             | 1740                  | 2160    | 2400                  | mV   |
| V <sub>OD</sub>                 |  |                           | 400mV Amplitude Setting                              | 600                   | 800     | 1000                  | mV   |
|                                 |  | l Output                  | 700mV Amplitude Setting                              | 950                   | 1400    | 1850                  | mV   |
|                                 | LVDS Differential<br>Voltage <sup>6</sup>  |                           | 1000mV Amplitude Setting                             | 1450                  | 2140    | 2600                  | mV   |
| $\Delta V_{OD}$                 | VCO Frequency<br>Output<br>Frequency <sup>2</sup><br>Peak-to-peak<br>Input Voltage <sup>3</sup><br>Common Mode<br>LVPECL Output<br>Swing, Peak-to-<br>LVPECL Differenti<br>Voltage Swing,<br>LVDS Differenti<br>Voltage <sup>6</sup><br>LVDS V <sub>OD</sub> Mag<br>Output Skew <sup>7, E</sup><br>Output Skew <sup>7, E</sup> | itude Change              |  |                       |         | 50                    | mV   |
|                                 |  | QCLKx                     | Same N divider, Delay = 0                            |                       | 65      | 110                   | ps   |
|                                 |  | QCLKx                     | Any N Divider, Incident Rising Edge,<br>Delay = 0    |                       | 75      | 140                   | ps   |
| <i>t</i> sk(o)                  | Output Skew <sup>7, 8</sup>  | QREFx                     | Delay = 0  |                       | 20      | 50                    | MHz<br>MHz<br>MHz<br>MHz<br>MHz<br>V<br>V<br>V<br>V<br>V<br>MV<br>MV<br>MV<br>MV<br>MV<br>MV<br>MV<br>MV<br>MV<br>MV                         |
|                                 |  | QREFx                     | Any Equal Delay Settings                             |                       | 20      | 50                    |  |
|                                 |  | QREFx to<br>QCLKx         | Any Divider, Incident Rising QCLK Edge,<br>Delay = 0 |                       | 110     | 200                   | ps   |
|                                 |  | QCLK<br>(LVPECL)          | 20% to 80%<br>700mV Amplitude setting                |                       | 150     | 300                   | ps   |
| t <sub>R</sub> / t <sub>F</sub> |  | QCLK<br>(LVDS)            | 20% to 80%<br>700mV Amplitude setting                |                       | 150     | 300                   | ps   |
|                                 |  | nINT, MISO                | 20%-80% - SELSV = 0                                  |                       | 1000    | 2650                  | ps   |
|                                 | Rise/Fall Time <sup>9</sup>  | (LVCMOS)                  | 20%-80% - SELSV = 1                                  |                       | 600     | 1000                  | ps   |
|                                 |  |                           | f <sub>OUT</sub> = 1228.8MHz                         | 52                    | 58      | 77                    | dB   |
|                                 | Output Isolation   |                           | $f_{OUT} = 614.4 MHz$                                | 55                    | 59      | 80                    | dB   |
|                                 |  |                           | f <sub>OUT</sub> = 307.2MHz                          | 58                    | 69      | 79                    | dB   |

| Symbol                   | Parameter     |            | Test Conditions   | Minimum | Typical | Maximum | Units |
|--------------------------|---------------|------------|---|---------|---------|---------|-------|
| odc Output<br>Duty Cycle | Output        | QCLK[8:0], | Divide by1  | 42      | 48      | 54      | %     |
|                          | Duty Cycle    | QREF[6:0]  | Other Dividers  | 45      | 50      | 55      | %     |
|                          |               | Ш          | VCXO-PLL Bandwidth = 30Hz,  |         | -       |         |       |
| t <sub>LOCK</sub>        | PLL Lock Time |            | Device fully powered, measured from<br>the first presence of a valid PLL<br>reference clock to the complete lock of<br>all PLLs |         | 210     | 1000    | ms    |

# Table 6A. AC Characteristics, $V_{DDx} = V_{DDQx} = 3.3V \pm 5\%$ , GND = 0V, $T_A = -40^{\circ}C$ to +85°C<sup>1</sup> (Continued)

NOTE 1. Electrical parameters are guaranteed over the specified ambient operating temperature range, which is established when the device is mounted in a test socket with maintained transverse airflow greater than 500 lfpm. The device will meet specifications after thermal equilibrium has been reached under these conditions. V<sub>DDQx</sub> denotes V<sub>DDQA</sub>, V<sub>DDQB</sub>, V<sub>DDQC</sub>. V<sub>DDx</sub> denotes V<sub>DD1</sub>, V<sub>DD2</sub>, V<sub>DD3</sub>, V<sub>DD4</sub>, V<sub>DD5</sub>, V<sub>DD6</sub>, V<sub>DD7</sub>.

NOTE 2. Used as clock output.

NOTE 3.  $V_{II}$  should not be less than -0.3V.

NOTE 4. Common mode input voltage is defined as the signal crosspoint.

NOTE 5. LVPECL outputs terminated with 50 $\Omega$  to V<sub>DDQx</sub> – 1.5V (400mV amplitude setting), V<sub>DDQx</sub> – 2.0V (700mV amplitude setting), V<sub>DDQx</sub> – 2.5V (1000mV amplitude setting).

NOTE 6. LVDS outputs terminated 100  $\Omega$  across terminals.

NOTE 7. This parameter is defined in accordance with JEDEC standard 65.

NOTE 8. Defined as skew between outputs at the same supply voltage and with equal load conditions. Measured at the differential cross points.

NOTE 9. Single-ended output nINT terminated according to Figure 12.

# Table 6B. 8V19N407-19 QCLK Phase Noise and Jitter Characteristics, $V_{DDx} = V_{DDQx} = 3.3V \pm 5\%$ , GND = 0V, $T_A = -40^{\circ}$ C to +85°C <sup>1, 2, 3, 4, 5, 6</sup>

| Symbol                | Parameter                    | Test Conditions                   | Minimum | Typical | Maximum | Units  |
|-----------------------|------------------------------|-----------------------------------|---------|---------|---------|--------|
| f = 983.04            | MHz                          |                                   | I       |         | ı       |        |
| f:1( <b>O</b> )       |                              | Integration Range: 1kHz - 76.8MHz |         | 104.7   | 160.6   | fs     |
| <i>t</i> jit(Ø)       | RMS Phase Jitter (Random)    | Integration Range: 12kHz - 20MHz  |         | 91.4    | 129.8   | fs     |
| Φ <sub>N</sub> (10)   |                              | 10Hz offset from Carrier          |         | -50.5   |         | dBc/Hz |
| Φ <sub>N</sub> (100)  | -                            | 100Hz offset from Carrier         |         | -85.6   |         | dBc/Hz |
| Φ <sub>N</sub> (1k)   | -                            | 1kHz offset from Carrier          |         | -116.2  | -93.0   | dBc/Hz |
| Φ <sub>N</sub> (10k)  | Cingle side Dand Dhase Naiss | 10kHz offset from Carrier         |         | -118.2  | -114.3  | dBc/Hz |
| Φ <sub>N</sub> (100k) | Single-side Band Phase Noise | 100kHz offset from Carrier        |         | -122.8  | -119.3  | dBc/Hz |
| Φ <sub>N</sub> (800k) | -                            | 800kHz offset from Carrier        |         | -142.6  | -139.8  | dBc/Hz |
| Φ <sub>N</sub> (1M)   | -                            | 1MHz offset from Carrier          |         | -144.7  | -141.7  | dBc/Hz |
| Φ <sub>N</sub> (∞)    | -                            | Noise Floor                       |         | -154    |         | dBc/Hz |
|                       |                              | 300Hz - 100kHz                    |         | -87     | -64     | dBc    |
|                       | Spurious Attenuation         | >100kHz                           |         | -85     | -63     | dBc    |
|                       | -                            | Phase Detector Spurious           |         | -69     | -61     | dBc    |
| f = 491.52            | MHz                          |                                   |         |         |         |        |
|                       |                              | Integration Range: 1kHz - 76.8MHz |         | 108.1   | 172.0   | fs     |
| <i>t</i> jit(Ø)       | RMS Phase Jitter (Random)    | Integration Range: 12kHz - 20MHz  |         | 92.4    | 145.0   | fs     |
| Φ <sub>N</sub> (10)   |                              | 10Hz offset from Carrier          |         | -57.1   |         | dBc/Hz |
| Φ <sub>N</sub> (100)  | -                            | 100Hz offset from Carrier         |         | -92.7   |         | dBc/Hz |
| Φ <sub>N</sub> (1k)   | -                            | 1kHz offset from Carrier          |         | -123.4  | -107.2  | dBc/Hz |
| Φ <sub>N</sub> (10k)  |                              | 10kHz offset from Carrier         |         | -124.5  | -120.7  | dBc/Hz |
| Φ <sub>N</sub> (100k) | Single-side Band Phase Noise | 100kHz offset from Carrier        |         | -128.9  | -125.3  | dBc/Hz |
| Φ <sub>N</sub> (800k) |                              | 800kHz offset from Carrier        |         | -148.2  | -145.1  | dBc/Hz |
| Φ <sub>N</sub> (1M)   | -                            | 1MHz offset from Carrier          |         | -150.0  | -146.8  | dBc/Hz |
| Φ <sub>N</sub> (∞)    | -                            | Noise Floor                       |         | -157    |         | dBc/Hz |
|                       |                              | 300Hz - 100kHz                    |         | -93     | -70     | dBc    |
|                       | Spurious Attenuation         | >100kHz                           |         | -85     | -66     | dBc    |
|                       | -                            | Phase Detector Spurious           |         | -76     | -63     | dBc    |
| f = 245.76            | MHz                          |                                   |         |         |         |        |
| () ( <b>C</b> )       |                              | Integration Range: 1kHz - 40MHz   |         | 124.1   | 175.4   | fs     |
| <i>t</i> jit(Ø)       | RMS Phase Jitter (Random)    | Integration Range: 12kHz - 20MHz  |         | 98.5    | 142.0   | fs     |
| Φ <sub>N</sub> (10)   |                              | 10Hz offset from Carrier          |         | -63.0   |         | dBc/Hz |
| Φ <sub>N</sub> (100)  | -                            | 100Hz offset from Carrier         |         | -98.2   |         | dBc/Hz |
| Φ <sub>N</sub> (1k)   | -                            | 1kHz offset from Carrier          |         | -129.2  | -112.0  | dBc/Hz |
| Φ <sub>N</sub> (10k)  |                              | 10kHz offset from Carrier         |         | -130.5  | -125.6  | dBc/Hz |
| Φ <sub>N</sub> (100k) | Single-side Band Phase Noise | 100kHz offset from Carrier        |         | -134.9  | -131.1  | dBc/Hz |
| Φ <sub>N</sub> (800k) |                              | 800kHz offset from Carrier        |         | -153.4  | -150.7  | dBc/Hz |
| Φ <sub>N</sub> (1M)   |                              | 1MHz offset from Carrier          |         | -154.8  | -152.0  | dBc/Hz |
| Φ <sub>N</sub> (∞)    |                              | Noise Floor                       |         | -160    |         | dBc/Hz |
|                       |                              | 300Hz - 100kHz                    |         | -95     |         | dBc    |
|                       | Spurious Attenuation         | >100kHz                           |         | -97     | -78     | dBc    |
|                       |                              | Phase Detector Spurious           |         | -87     |         | dBc    |

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- NOTE 1. Electrical parameters are guaranteed over the specified ambient operating temperature range, which is established when the device is mounted in a test socket with maintained transverse airflow greater than 500 lfpm. The device will meet specifications after thermal equilibrium has been reached under these conditions.
- NOTE 2. V<sub>DDQx</sub> denotes V<sub>DDQA</sub>, V<sub>DDQB</sub>, V<sub>DDQC</sub>, V<sub>DDx</sub> denotes V<sub>DD1</sub>, V<sub>DD2</sub>, V<sub>DD3</sub>, V<sub>DD4</sub>, V<sub>DD5</sub>, V<sub>DD6</sub>, V<sub>DD7</sub>.
- NOTE 3. Phase noise and spurious specifications apply for device operation with QREFn outputs inactive (no SYSREF pulses generated).
- NOTE 4. A VCXO has been used with Phase Noise and Spurious Attenuation measurements with typical offset values of 1kHz -131dBc/Hz, 10kHz -155dBc/Hz, 100kHz -160dBc/Hz and 1MHz -162dBc/Hz.
- NOTE 5. Voltage regulator to supply  $V_{DDX}$  was used with a typical power supply rejection ratio of 80dB at 1kHz and ultra low noise generation with a typical value of  $3nV/\sqrt{Hz}$  at 10kHz and  $7nV/\sqrt{Hz}$  at 1kHz.

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NOTE 6. Outputs configured as LVDS 700mV.

# Table 6C. 8V19N407-24 QCLK Phase Noise and Jitter Characteristics, $V_{DDx} = V_{DDQx} = 3.3V \pm 5\%$ , GND = 0V, $T_A = -40^{\circ}$ C to +85°C <sup>1, 2, 3, 4, 5, 6</sup>

| Symbol                | Parameter                    | Test Conditions                   | Minimum | Typical | Maximum | Units  |
|-----------------------|------------------------------|-----------------------------------|---------|---------|---------|--------|
| f = 1228.8            | MHz                          |                                   | l       |         |         |        |
| f;;+( <b>((</b> ))    | RMS Phase Jitter (Random)    | Integration Range: 1kHz - 76.8MHz |         | 82.5    | 114.1   | fs     |
| <i>t</i> jit(Ø)       | RMS Phase Siller (Random)    | Integration Range: 12kHz - 20MHz  |         | 73.7    | 103.5   | fs     |
| Φ <sub>N</sub> (10)   |                              | 10Hz offset from Carrier          |         | -52.5   |         | dBc/Hz |
| Φ <sub>N</sub> (100)  | -                            | 100Hz offset from Carrier         |         | -86.8   |         | dBc/Hz |
| $\Phi_{N}(1k)$        | -                            | 1kHz offset from Carrier          |         | -116.9  | -111.7  | dBc/Hz |
| Φ <sub>N</sub> (10k)  |                              | 10kHz offset from Carrier         |         | -118.1  | -114.1  | dBc/Hz |
| Φ <sub>N</sub> (100k) | Single-side Band Phase Noise | 100kHz offset from Carrier        |         | -122.7  | -119.4  | dBc/Hz |
| Φ <sub>N</sub> (800k) | -                            | 800kHz offset from Carrier        |         | -142.7  | -139.8  | dBc/Hz |
| Φ <sub>N</sub> (1M)   | -                            | 1MHz offset from Carrier          |         | -144.7  | -141.7  | dBc/Hz |
| Φ <sub>N</sub> (∞)    |                              | Noise Floor                       |         | -154    |         | dBc/Hz |
|                       |                              | 300Hz - 100kHz                    |         | -92     | -75     | dBc    |
|                       | Spurious Attenuation         | >100kHz                           |         | -85     | -74     | dBc    |
|                       |                              | Phase Detector Spurious           |         | -68     | -60     | dBc    |
| f = 614.4M            | Hz                           |                                   |         |         |         |        |
| £:+( <b>C</b> )       | DMC Diseas litter (Dandam)   | Integration Range: 1kHz - 76.8MHz |         | 99.8    | 132.0   | fs     |
| <i>t</i> jit(Ø)       | RMS Phase Jitter (Random)    | Integration Range: 12kHz - 20MHz  |         | 80.9    | 110.9   | fs     |
| Φ <sub>N</sub> (10)   |                              | 10Hz offset from Carrier          |         | -58.4   |         | dBc/Hz |
| Φ <sub>N</sub> (100)  |                              | 100Hz offset from Carrier         |         | -93.0   |         | dBc/Hz |
| Φ <sub>N</sub> (1k)   |                              | 1kHz offset from Carrier          |         | -122.3  | -118.2  | dBc/Hz |
| $\Phi_{\sf N}(10k)$   |                              | 10kHz offset from Carrier         |         | -123.6  | -119.6  | dBc/Hz |
| Φ <sub>N</sub> (100k) | Single-side Band Phase Noise | 100kHz offset from Carrier        |         | -128.3  | -125.2  | dBc/Hz |
| Φ <sub>N</sub> (800k) | -                            | 800kHz offset from Carrier        |         | -147.7  | -144.8  | dBc/Hz |
| Φ <sub>N</sub> (1M)   |                              | 1MHz offset from Carrier          |         | -149.4  | -146.4  | dBc/Hz |
| Φ <sub>N</sub> (∞)    |                              | Noise Floor                       |         | -154    |         | dBc/Hz |
|                       |                              | 300Hz - 100kHz                    |         | -95     | -81     | dBc    |
|                       | Spurious Attenuation         | >100kHz                           |         | -85     | -69     | dBc    |
|                       |                              | Phase Detector Spurious           |         | -79     | -68     | dBc    |
| f = 307.2M            | Hz                           |                                   |         |         |         |        |
| £:+( <b>C</b> )       | DMC Diseas litter (Dandam)   | Integration Range: 1kHz - 76.8MHz |         | 101.9   | 136.4   | fs     |
| <i>t</i> jit(Ø)       | RMS Phase Jitter (Random)    | Integration Range: 12kHz - 20MHz  |         | 81.3    | 111.6   | fs     |
| Φ <sub>N</sub> (10)   |                              | 10Hz offset from Carrier          |         | -64.0   |         | dBc/Hz |
| Φ <sub>N</sub> (100)  |                              | 100Hz offset from Carrier         |         | -98.7   |         | dBc/Hz |
| $\Phi_{\sf N}(1k)$    |                              | 1kHz offset from Carrier          |         | -128.9  | -124.9  | dBc/Hz |
| $\Phi_{\sf N}(10k)$   | Single side Dand Dhase Naire | 10kHz offset from Carrier         |         | -130.1  | -122.0  | dBc/Hz |
| Φ <sub>N</sub> (100k) | Single-side Band Phase Noise | 100kHz offset from Carrier        |         | -134.6  | -131.3  | dBc/Hz |
| Φ <sub>N</sub> (800k) |                              | 800kHz offset from Carrier        |         | -153.2  | -150.2  | dBc/Hz |
| Φ <sub>N</sub> (1M)   |                              | 1MHz offset from Carrier          |         | -154.6  | -151.5  | dBc/Hz |
| Φ <sub>N</sub> (∞)    |                              | Noise Floor                       |         | -160    |         | dBc/Hz |

| Table 6C. 8V19N407-24 QCLK Phase Noise and Jitter Characteristics, $V_{DDx} = V_{DDQx} = 3.3V \pm 5\%$ , GND = 0 | Ι, |
|--|----|
| T <sub>A</sub> = -40°C to +85°C <sup>1, 2, 3, 4, 5, 6</sup>  |    |

| Symbol                | Parameter                    | Test Conditions                  | Minimum | Typical | Maximum | Units  |
|-----------------------|------------------------------|----------------------------------|---------|---------|---------|--------|
|                       | Spurious Attenuation         | 300Hz - 100kHz                   |         | -98     | -81     | dBc    |
|                       |                              | >100kHz                          |         | -96     | -79     | dBc    |
|                       |                              | Phase Detector Spurious          |         | -80     |         | dBc    |
| f = 156.25            | MHz                          |                                  |         |         |         |        |
| <i>t</i> jit(Ø)       | RMS Phase Jitter (Random)    | Integration Range: 1kHz - 40MHz  |         | 103.3   | 139.2   | fs     |
|                       |                              | Integration Range: 12kHz - 20MHz |         | 83.7    | 114.7   | fs     |
| Φ <sub>N</sub> (10)   | Single-side Band Phase Noise | 10Hz offset from Carrier         |         | -69.1   |         | dBc/Hz |
| Φ <sub>N</sub> (100)  |                              | 100Hz offset from Carrier        |         | -103.3  |         | dBc/Hz |
| $\Phi_{\sf N}(1k)$    |                              | 1kHz offset from Carrier         |         | -133.5  | -124.9  | dBc/Hz |
| $\Phi_{\sf N}(10k)$   |                              | 10kHz offset from Carrier        |         | -137.2  | -132.7  | dBc/Hz |
| Φ <sub>N</sub> (100k) |                              | 100kHz offset from Carrier       |         | -142.4  | -137.9  | dBc/Hz |
| Φ <sub>N</sub> (1M)   |                              | 1MHz offset from Carrier         |         | -158.4  | -155.6  | dBc/Hz |
| Φ <sub>N</sub> (∞)    |                              | Noise Floor                      |         | -161.8  |         | dBc/Hz |
| f = 125MH             | Z                            |                                  |         |         |         |        |
| <i>t</i> jit(Ø)       | RMS Phase Jitter (Random)    | Integration Range: 1kHz - 40MHz  |         | 146.8   | 185.2   | fs     |
|                       |                              | Integration Range: 12kHz - 20MHz |         | 109.8   | 142.4   | fs     |
| Φ <sub>N</sub> (10)   | Single-side Band Phase Noise | 10Hz offset from Carrier         |         | -70.4   |         | dBc/Hz |
| Φ <sub>N</sub> (100)  |                              | 100Hz offset from Carrier        |         | -104.9  |         | dBc/Hz |
| $\Phi_{\sf N}(1k)$    |                              | 1kHz offset from Carrier         |         | -135.8  | -125.9  | dBc/Hz |
| Φ <sub>N</sub> (10k)  |                              | 10kHz offset from Carrier        |         | -139.0  | -134.1  | dBc/Hz |
| Φ <sub>N</sub> (100k) |                              | 100kHz offset from Carrier       |         | -143.8  | -138.4  | dBc/Hz |
| Φ <sub>N</sub> (1M)   |                              | 1MHz offset from Carrier         |         | -157.3  | -155.0  | dBc/Hz |
| Φ <sub>N</sub> (∞)    |                              | Noise Floor                      |         | -158.9  |         | dBc/Hz |

NOTE 1. Electrical parameters are guaranteed over the specified ambient operating temperature range, which is established when the device is mounted in a test socket with maintained transverse airflow greater than 500 lfpm. The device will meet specifications after thermal equilibrium has been reached under these conditions.

NOTE 2. V<sub>DDQx</sub> denotes V<sub>DDQA</sub>, V<sub>DDQB</sub>, V<sub>DDQC</sub>, V<sub>DDx</sub> denotes V<sub>DD1</sub>, V<sub>DD2</sub>, V<sub>DD3</sub>, V<sub>DD4</sub>, V<sub>DD5</sub>, V<sub>DD6</sub>, V<sub>DD7</sub>.

NOTE 3. Phase noise and spurious specifications apply for device operation with QREFn outputs inactive (no SYSREF pulses generated).

NOTE 4. A VCXO has been used with Phase Noise and Spurious Attenuation measurements with typical values of 1kHz -131dBc/Hz, 10kHz -155dBc/Hz, 100kHz -160dBc/Hz and 1MHz -162dBc/Hz.

NOTE 5. Voltage regulator to supply  $V_{DDX}$  was used with a typical power supply rejection ratio of 80dB at 1kHz and ultra low noise generation with a typical value of  $3nV/\sqrt{Hz}$  at 10kHz and  $7nV/\sqrt{Hz}$  at 1kHz.

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NOTE 6. Outputs configured as LVDS 700mV.

# Table 6D. 8V19N407-19 QREF Phase Noise and Spurious Characteristics, $V_{DDx} = V_{DDQx} = 3.3V \pm 5\%$ , GND = 0V, $T_A = -40^{\circ}C$ to +85°C<sup>1, 2, 3, 4, 5, 6</sup>

| Symbol                | Parameter  | Test Conditions            | Minimum | Typical | Maximum | Units  |
|-----------------------|--|----------------------------|---------|---------|---------|--------|
| Φ <sub>N</sub> (1k)   |  | 1kz offset from Carrier    |         | -130    |         | dBc/Hz |
| Φ <sub>N</sub> (10k)  | Single-side Band Phase Noise<br>(SYSREF = 15MHz) | 10kHz offset from Carrier  |         | -150    |         | dBc/Hz |
| Φ <sub>N</sub> (100k) |  | 100kHz offset from Carrier |         | -155    |         | dBc/Hz |
| Φ <sub>N</sub> (1M)   |  | 1MHz offset from Carrier   |         | -156    |         | dBc/Hz |
|                       |  | 300Hz - 100kHz             |         | -90     |         | dBc    |
|                       | Spurious Attenuation                             | >100kHz                    |         | -85     |         | dBc    |
|                       |  | Phase Detector Spurious    |         | -85     |         | dBc    |

NOTE 1. Electrical parameters are guaranteed over the specified ambient operating temperature range, which is established when the device is mounted in a test socket with maintained transverse airflow greater than 500 lfpm. The device will meet specifications after thermal equilibrium has been reached under these conditions.

NOTE 2. V<sub>DDQx</sub> denotes V<sub>DDQA</sub>, V<sub>DDQB</sub>, V<sub>DDQC</sub>, V<sub>DDx</sub> denotes V<sub>DD1</sub>, V<sub>DD2</sub>, V<sub>DD3</sub>, V<sub>DD4</sub>, V<sub>DD5</sub>, V<sub>DD6</sub>, V<sub>DD7</sub>.

- NOTE 3. Phase noise specifications are applicable for all outputs.
- NOTE 4. A VCXO has been used with Phase Noise and Spurious Attenuation measurements with typical values of 1kHz -131dBc/Hz, 10kHz -155dBc/Hz, 100kHz -160dBc/Hz and 1MHz -162dBc/Hz.
- NOTE 5. Voltage regulator to supply  $V_{DDX}$  was used with a typical power supply rejection ratio of 80dB at 1kHz and ultra low noise generation with a typical value of  $3nV/\sqrt{Hz}$  at 10kHz and  $7nV/\sqrt{Hz}$  at 1kHz.
- NOTE 6. Outputs configured as LVDS 700mV.

# Table 6E. 8V19N407-24 QREF Phase Noise and Spurious Characteristics, $V_{DDx} = V_{DDQx} = 3.3V \pm 5\%$ , GND = 0V, $T_A = -40^{\circ}$ C to $+85^{\circ}$ C<sup>1, 2, 3, 4, 5, 6</sup>

| Symbol                | Parameter  | Test Conditions            | Minimum | Typical | Maximum | Units  |
|-----------------------|--|----------------------------|---------|---------|---------|--------|
| Φ <sub>N</sub> (1k)   |  | 1kz offset from Carrier    |         | -132    |         | dBc/Hz |
| Φ <sub>N</sub> (10k)  | Single-side Band Phase Noise<br>(SYSREF = 19.2MHz)<br>Spurious Attenuation | 10kHz offset from Carrier  |         | -147    |         | dBc/Hz |
| Φ <sub>N</sub> (100k) |  | 100kHz offset from Carrier |         | -155    |         | dBc/Hz |
| Φ <sub>N</sub> (1M)   |  | 1MHz offset from Carrier   |         | -156    |         | dBc/Hz |
|                       |  | 300Hz - 100kHz             |         | -88     |         | dBc    |
|                       |  | >100kHz                    |         | -85     |         | dBc    |
|                       |  | Phase Detector Spurious    |         | -85     |         | dBc    |

NOTE 1. Electrical parameters are guaranteed over the specified ambient operating temperature range, which is established when the device is mounted in a test socket with maintained transverse airflow greater than 500 lfpm. The device will meet specifications after thermal equilibrium has been reached under these conditions.

NOTE 2. V<sub>DDQx</sub> denotes V<sub>DDQA</sub>, V<sub>DDQB</sub>, V<sub>DDQC</sub>. V<sub>DDx</sub> denotes V<sub>DD1</sub>, V<sub>DD2</sub>, V<sub>DD3</sub>, V<sub>DD4</sub>, V<sub>DD5</sub>, V<sub>DD6</sub>, V<sub>DD7</sub>.

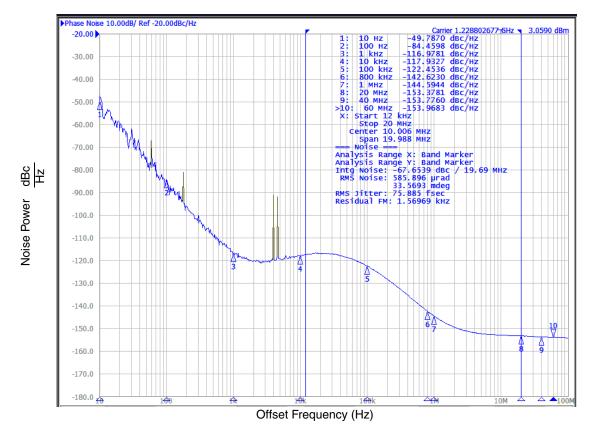
NOTE 3. Phase noise specifications are applicable for all outputs active, Nx not equal.

NOTE 4. A VCXO has been used with Phase Noise and Spurious Attenuation measurements with typical values of 1kHz -131dBc/Hz, 10kHz -155dBc/Hz, 100kHz -160dBc/Hz and 1MHz -162dBc/Hz.

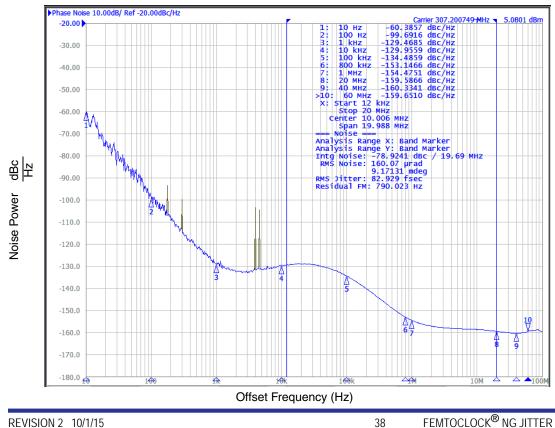
NOTE 5. Voltage regulator to supply  $V_{DDX}$  was used with a typical power supply rejection ratio of 80dB at 1kHz and ultra low noise generation with a typical value of  $3nV/\sqrt{Hz}$  at 10kHz and  $7nV/\sqrt{Hz}$  at 1kHz.

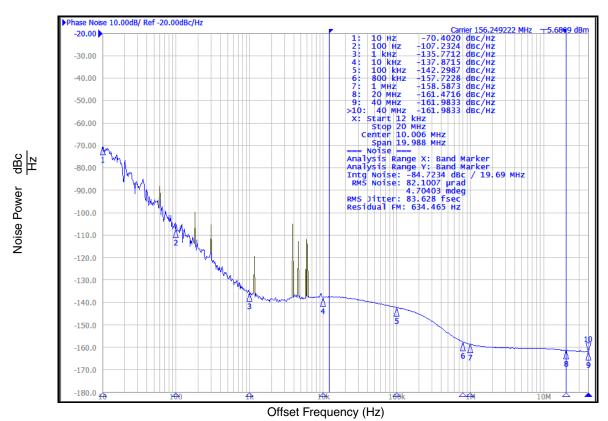
NOTE 6. Outputs configured as LVDS 700mV.

## Typical Phase Noise at 1228.8MHz



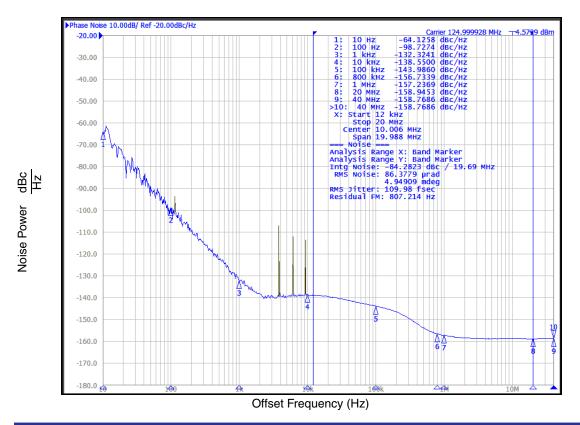
**Typical Phase Noise at 307.2MHz** 



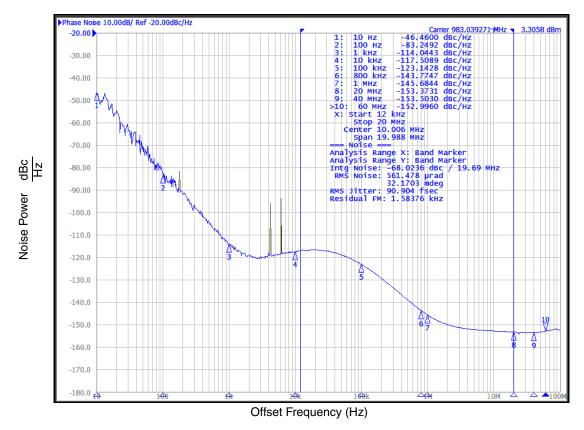


# Typical Phase Noise at 156.25MHz

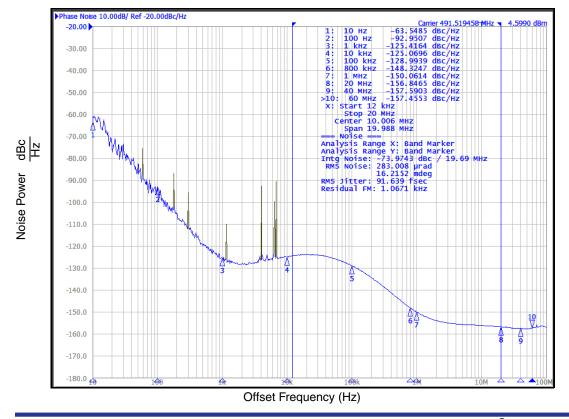
Typical Phase Noise at 125MHz

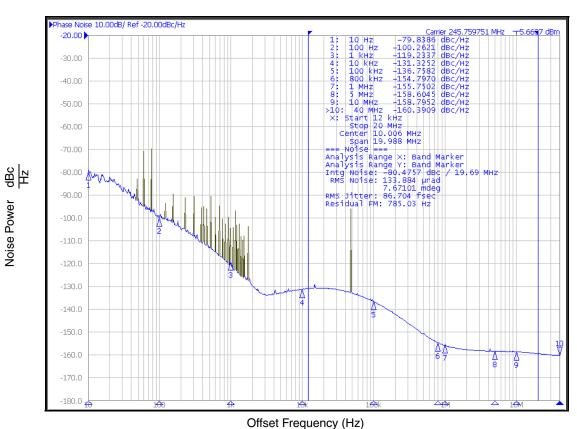


## Typical Phase Noise at 983.04MHz



Typical Phase Noise at 491.52MHz

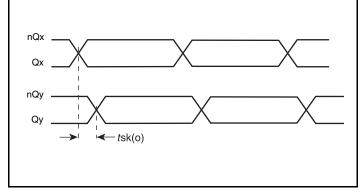




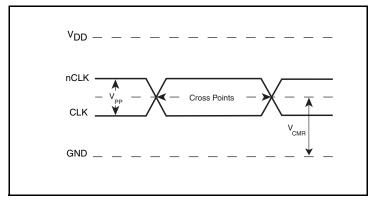
## **Typical Phase Noise at 245.76MHz**

FEMTOCLOCK<sup>®</sup> NG JITTER ATTENUATOR AND CLOCK SYNTHESIZER

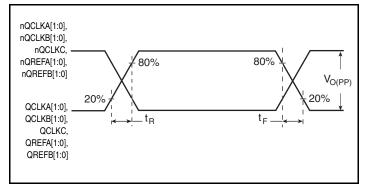
## **Parameter Measurement Information**



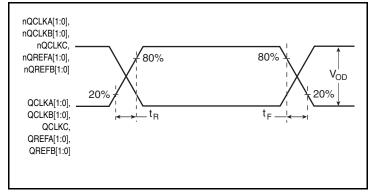




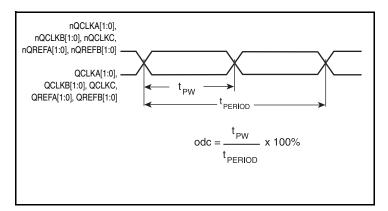
**Differential Input Level** 



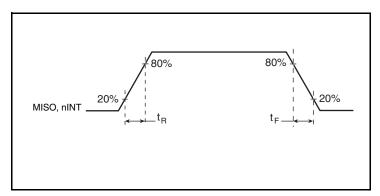
LVPECL Output Rise/Fall Time







Differential Output Duty Cycle/Pulse Width/Period



LVCMOS Output Rise/Fall Time

# **Applications Information**

## **Recommendations for Unused Input and Output Pins**

### Inputs:

## LVCMOS Control Pins

All control pins have internal pullups or pulldowns; additional resistance is not required but can be added for additional protection. A  $1k\Omega$  resistor can be used.

### **Outputs:**

### **LVPECL Outputs**

Any unused LVPECL output pair can be left floating. We recommend that there is no trace attached. Both sides of the differential output pair should either be left floating or terminated.

#### **LVDS Outputs**

All unused LVDS output pairs can be either left floating or terminated with  $100\Omega$  across. If they are left floating, there should be no trace attached.



## Wiring the Differential Input to Accept Single-Ended Levels

Figure 4 shows how a differential input can be wired to accept single ended levels. The reference voltage  $V_1 = V_{DD}/2$  is generated by the bias resistors R1 and R2. The bypass capacitor (C1) is used to help filter noise on the DC bias. This bias circuit should be located as close to the input pin as possible. The ratio of R1 and R2 might need to be adjusted to position the  $V_1$  in the center of the input voltage swing. For example, if the input clock is driven from a single-ended 2.5V LVCMOS driver and the DC offset (or swing center) of this signal is 1.25V, the R1 and R2 values should be adjusted to set the V1 at 1.25V. The values below are for when both the single ended swing and  $V_{DD}$  are at the same voltage. This configuration requires that the sum of the output impedance of the driver (Ro) and the series resistance (Rs) equals the transmission line impedance. In addition, matched termination at the input will attenuate the signal in half. This can be done in one of two ways. First, R3 and R4 in parallel should equal the transmission line impedance. For most 50 $\Omega$  applications, R3 and R4 can be 100 $\Omega$ . The values of the resistors can be increased to reduce the loading for slower and weaker LVCMOS driver. When using single-ended signaling, the noise rejection benefits of differential signaling are reduced. Even though the differential input can handle full rail LVCMOS signaling, it is recommended that the amplitude be reduced while maintaining an edge rate faster than 1V/ns. The datasheet specifies a lower differential amplitude, however this only applies to differential signals. For single-ended applications, the swing can be larger, however V<sub>IL</sub> cannot be less than -0.3V and V<sub>IH</sub> cannot be more than V<sub>DD</sub> + 0.3V. Though some of the recommended components might not be used, the pads should be placed in the layout. They can be utilized for debugging purposes. The datasheet specifications are characterized and guaranteed by using a differential signal.

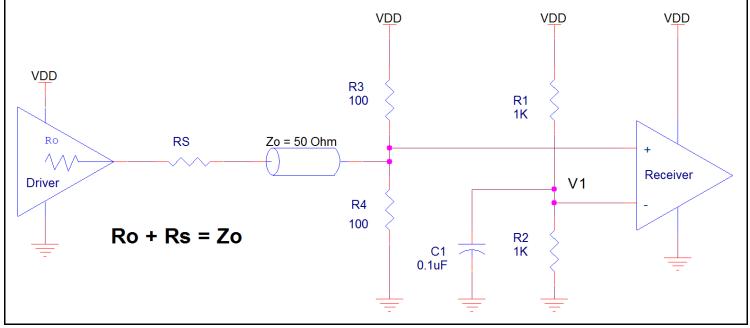


Figure 4. Recommended Schematic for Wiring a Differential Input to Accept Single-ended Levels

## 3.3V Differential Clock Input Interface

The CLK /nCLK accepts LVDS, LVPECL and other differential signals. Both differential inputs must meet the V<sub>PP</sub> and V<sub>CMR</sub> input requirements. Figure 5A to Figure 5C show interface examples for the CLK /nCLK input with built-in  $50\Omega$  terminations driven by the most

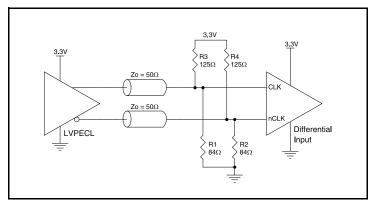


Figure 5A. CLK/nCLK Input Driven by a 3.3V LVPECL Driver

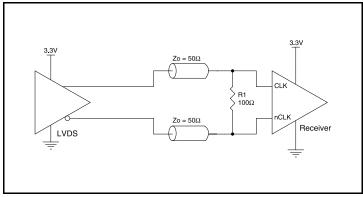
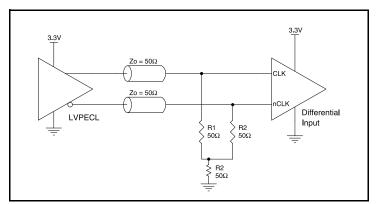


Figure 5B. CLK/nCLK Input Driven by a 3.3V LVDS Driver

common driver types. The input interfaces suggested here are examples only. If the driver is from another vendor, use their termination recommendation. Please consult with the vendor of the driver component to confirm the driver termination requirements.





## **VFQFN EPAD Thermal Release Path**

In order to maximize both the removal of heat from the package and the electrical performance, a land pattern must be incorporated on the Printed Circuit Board (PCB) within the footprint of the package corresponding to the exposed metal pad or exposed heat slug on the package, as shown in Figure 6. The solderable area on the PCB, as defined by the solder mask, should be at least the same size/shape as the exposed pad/slug area on the package to maximize the thermal/electrical performance. Sufficient clearance should be designed on the PCB between the outer edges of the land pattern and the inner edges of pad pattern for the leads to avoid any shorts.

While the land pattern on the PCB provides a means of heat transfer and electrical grounding from the package to the board through a solder joint, thermal vias are necessary to effectively conduct from the surface of the PCB to the ground plane(s). The land pattern must be connected to ground through these vias. The vias act as "heat pipes". The number of vias (i.e. "heat pipes") are application specific and dependent upon the package power dissipation as well as electrical conductivity requirements. Thus, thermal and electrical analysis and/or testing are recommended to determine the minimum number needed. Maximum thermal and electrical performance is achieved when an array of vias is incorporated in the land pattern. It is recommended to use as many vias connected to ground as possible. It is also recommended that the via diameter should be 12 to 13mils (0.30 to 0.33mm) with 1oz copper via barrel plating. This is desirable to avoid any solder wicking inside the via during the soldering process which may result in voids in solder between the exposed pad/slug and the thermal land. Precautions should be taken to eliminate any solder voids between the exposed heat slug and the land pattern. Note: These recommendations are to be used as a guideline only. For further information, please refer to the Application Note on the Surface Mount Assembly of Amkor's Thermally/ Electrically Enhance Lead frame Base Package, Amkor Technology.

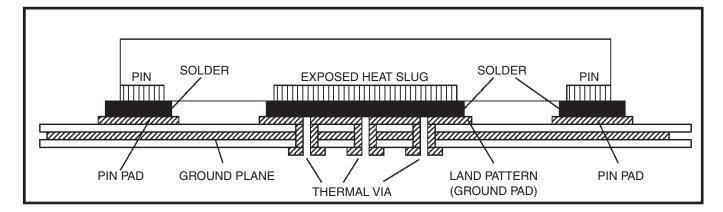


Figure 6. P.C. Assembly for Exposed Pad Thermal Release Path – Side View (drawing not to scale)

# **Termination Information**

### Termination for QCLK LVPECL Outputs (EF = 1)

Figure 7 shows an example of the termination for a QCLK LVPECL driver. In this example, the transmission line characteristic impedance is  $50\Omega$ . The R1 and R2  $50\Omega$  resistors are matched load terminations and are terminated to the voltage V<sub>T</sub>. V<sub>T</sub> should be set to a voltage according to the output amplitude in Table 2G. The termination resistors must be placed close to the receiver (line end)

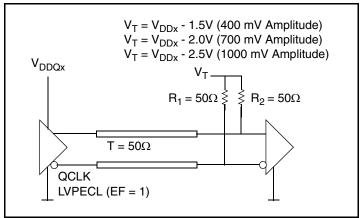


Figure 7. QCLK LVPECL (EF = 1) Output Termination

### Termination for QCLK LVDS Outputs (EF = 0)

Figure 8 and Figure 9 show examples of the termination for a QCLK and QREF LVDS drivers. In these examples, the transmission line characteristic impedance is  $50\Omega$ . The  $100\Omega$  resistor R is matched to the line impedance. The output amplitude is configurable, see Table 2G. The termination resistor must be placed close to the receiver (line end) or is internal to the receiver.

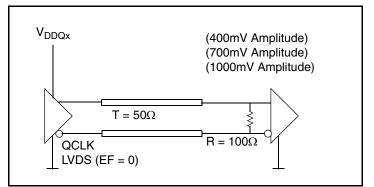


Figure 8. QCLK LVDS (EF = 0) Output Termination

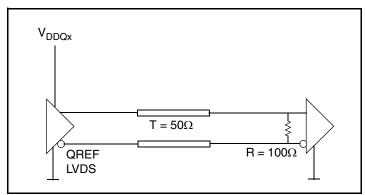


Figure 9. DC Termination for QREF LVDS Outputs

#### AC Termination for QREF LVDS Outputs

Figure 10 shows an example of the AC termination for the QREF LVDS driver. In this example, the transmission line characteristic impedance is  $50\Omega$ . A  $100\Omega$  AC-line termination must be placed close to the receiver (line end) or is internal to the receiver. The receiver input should be re-biased according to its common mode range specifications.

Figure 11 shows an example of the termination for the QREF LVDS driver. In this example, the transmission line characteristic impedance is  $50\Omega$ . The  $100\Omega$  resistor R is matched to the line impedance. The output amplitude is configurable, see Table 2G. The termination resistor must be placed close to the receiver (line end). A The receiver input should be re-biased according to its common mode range specifications.

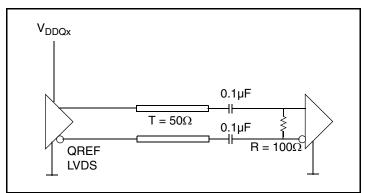


Figure 10. AC Termination for QREF LVDS Outputs

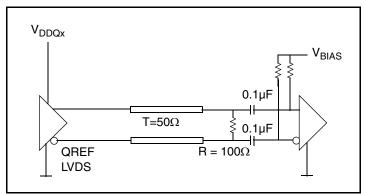


Figure 11. AC Termination for QREF LVDS Outputs

#### Termination for Single-ended Outputs (nINT)

Figure 12 shows an example of the series termination for the nINT LVCMOS driver. In this example, the transmission line characteristic impedance is  $50\Omega$ .

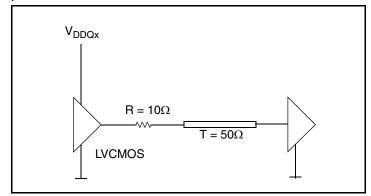


Figure 12. Termination for single-ended Outputs

## Schematic Example

Figure 13 and Figure 14 (next page) show an example 8V19N407 application schematic in which the device is operated at  $V_{DD} = 3.3V$ .

This example focuses on functional connections and is not configuration specific. Refer to the pin description and functional tables in the datasheet to ensure that the logic control inputs are properly set for the application.

The required generic VCXO shown requires a separate power filter and a termination for the VCXO output type. Since the type is not specified, neither is a specific termination. The loop filter for the external VCXO is three poles for best out of band rejection. The corresponding loop filter for the internal VCO is specified as three poles even though only two poles are populated. This leaves the option of increasing the filter order based on system level test.

The output terminations and clock receivers shown in Figure 13 are representative examples. AC coupled LVDS terminations are also permissible as shown in the Section, "Termination Information".

As with any high speed analog circuitry, the power supply pins are vulnerable to board supply or device generated noise. This device requires an external voltage regulator for the  $V_{DDx}$  pins for isolation of board supply noise. This regulator is indicated in the schematic by the two different power supplies, VREG\_3.3V and 3.3V. Consult the voltage regulator specification for details of the required performance.

To achieve optimum jitter performance, power supply isolation is required to minimize device generated noise. The 8V19N407 provides separate power supplies to isolate any high switching noise from coupling into the internal PLL as shown in Figure 14.

In order to achieve the best possible filtering, it is recommended that the placement of the filter components be on the device side of the PCB as close to the power pins as possible. If space is limited the 0.1 uf capacitor in each power pin filter should be placed on the device side. The other components can be on the opposite side of the PCB. Pull up and pull down resistors to set configuration pins can all be placed on the PCB side opposite the device side to free up device side area if necessary.

Power supply filter recommendations are a general guideline to be used for reducing external noise from coupling into the devices. The filter performance is designed for a wide range of noise frequencies. This low-pass filter starts to attenuate noise at approximately 10kHz. If a specific frequency noise component is known, such as switching power supplies frequencies, it is recommended that component values be adjusted and if required, additional filtering be added. Additionally, good general design practices for power plane voltage stability suggests adding bulk capacitance in the local area of all devices.

For additional layout recommendations and guidelines, contact clocks@idt.com.

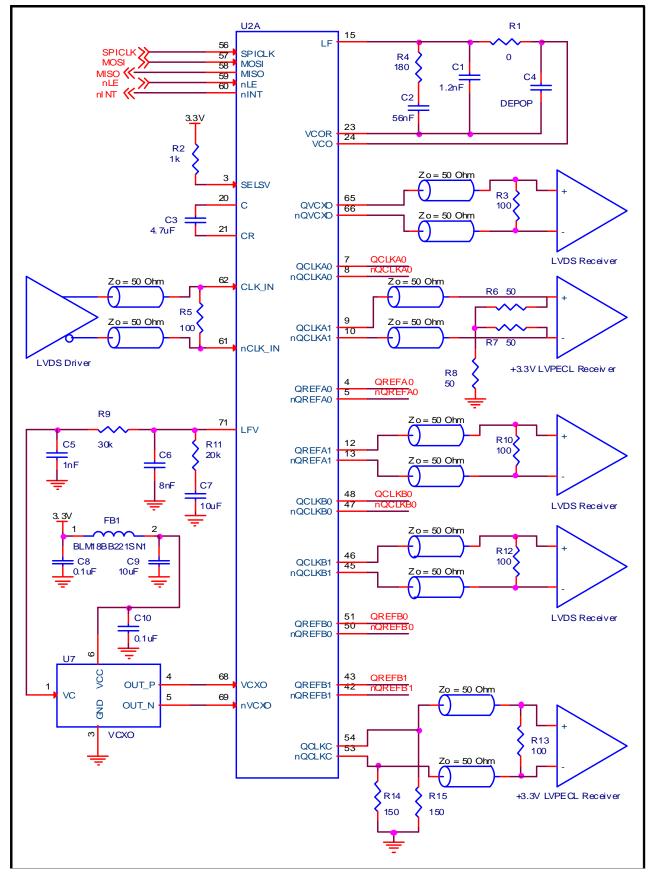
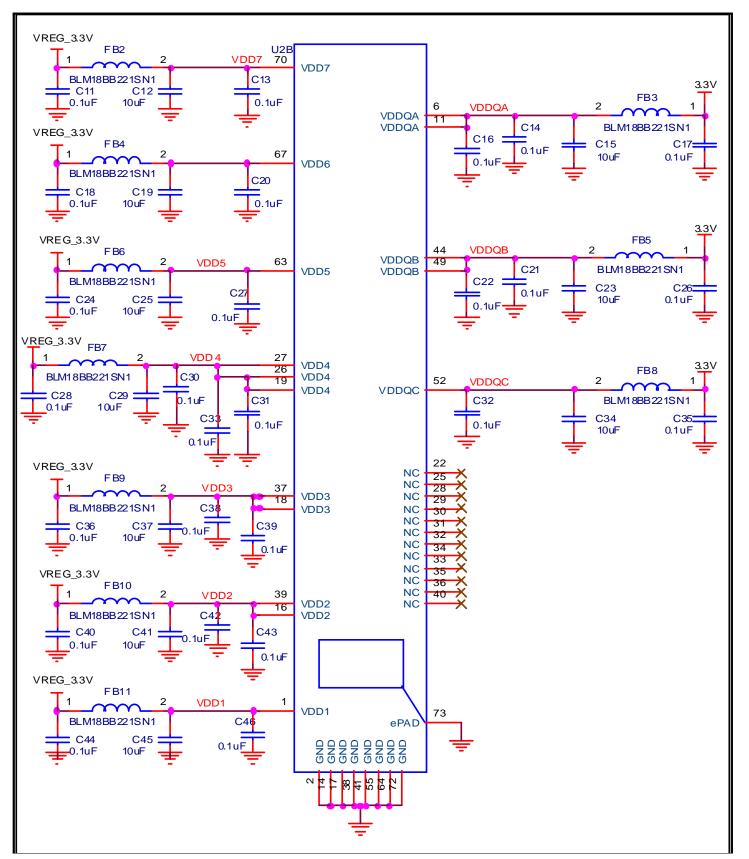


Figure 13. Signal I/O, External VCXO and Loop Filters



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#### Figure 14. Power Filters

## **Power Considerations**

The 8V19N407 device was designed and characterized to operate within the ambient extended temperature range of -40°C to 85°C. The ambient temperature represents the temperature around the device, not the junction temperature. Extreme care must be taken to avoid exceeding the 125°C junction temperature, potentially damaging the device.

Equations and example calculations are also provided below.

#### 1. Power Dissipation.

The power dissipation for the 8V19N407 is the product of supply voltage and total I<sub>DD</sub>. The following is the power dissipation for V<sub>DD</sub> = 3.3V + 5% = 3.465V at ambient temperature of 85°C.

Maximum current at 85°C,  $I_{DD_TOTAL_MAX} = I_{DD_MAX} + I_{DDQ_MAX}$  (All QCLKx and QVCXO are running with 700mV amplitude in LVDS mode and Continuous SYSREFs are running with 400mV amplitude in LVDS mode)

Total Power Dissipation: P<sub>D</sub> = V<sub>DD\_MAX</sub> \* I<sub>DD\_MAX</sub> = 3.465V \* (370mA + 620mA) = 3.430W

#### 2. Junction Temperature.

Junction temperature, Tj, signifies the hottest point on the device and exceeding the specified limit could cause device reliability issues. The maximum recommended junction temperature is 125°C.

For devices like this and in systems where most heat escapes from the bottom exposed pad of the package,  $\theta_{JB}$  is the primary thermal resistance of interest.

The equation to calculate Tj using  $\theta_{JB}$  is: Tj =  $\theta_{JB}$  \* P<sub>D</sub> + T<sub>B</sub>

Tj = Junction Temperature

 $\theta_{JB}$  = Junction-to-Board Thermal Resistance

P<sub>D</sub> = Device Power Dissipation (example calculation is in section 1 above)

T<sub>B</sub> = Board Temperature

In order to calculate junction temperature, the appropriate junction-to-board thermal resistance  $\theta_{JB}$  must be used. Assuming a 2-ground plane board, the appropriate value of  $\theta_{JB}$  is 0.713°C/W per Table 7 below.

Therefore, Tj for a PCB maintained at 115°C with all outputs switching is:

115°C + 3.430W \* 0.713°C/W = 117.4°C which is below the limit of 125°C.

This calculation is only an example. Tj will obviously vary depending on the number of loaded outputs, supply voltage, air flow, heat transfer method, the type of board (multi-layer) and the actual maintained board temperature. The below table is for two ground planes. The thermal resistance will change as the number of layers in the board changes or if the board size change and other changes in other factors impacts heat dissipation in the system.

#### Table 7. Thermal Resistances for 72-Lead VFQFN Package

| Air Flow (m/s) | 0         | 1         | 2         |
|----------------|-----------|-----------|-----------|
| $\theta_{JB}$  | 0.713°C/W | 0.713°C/W | 0.713°C/W |
| $\theta_{JA}$  | 19.16°C/W | 15.49°C/W | 14.14°C/W |

NOTE: Applicable to PCBs with two ground planes.

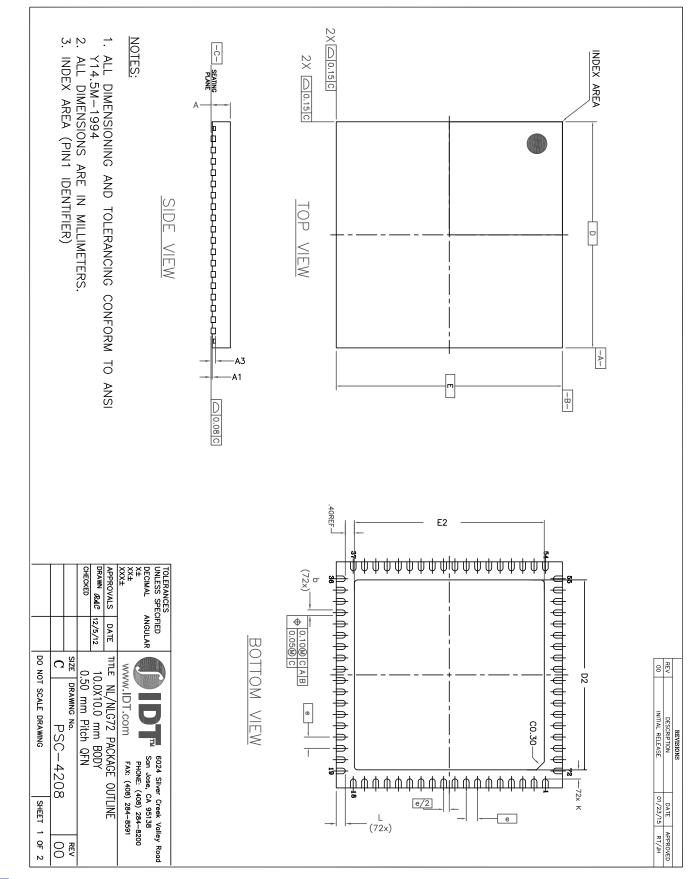
NOTE: ePAD size is 8.4mm x 8.4mm and connected to ground plane in PCB through 8 x 8 Thermal Via Array.

NOTE: In devices where most of the heat exits through the bottom ePAD,  $\theta_{JB}$  is commonly used for thermal calculations.

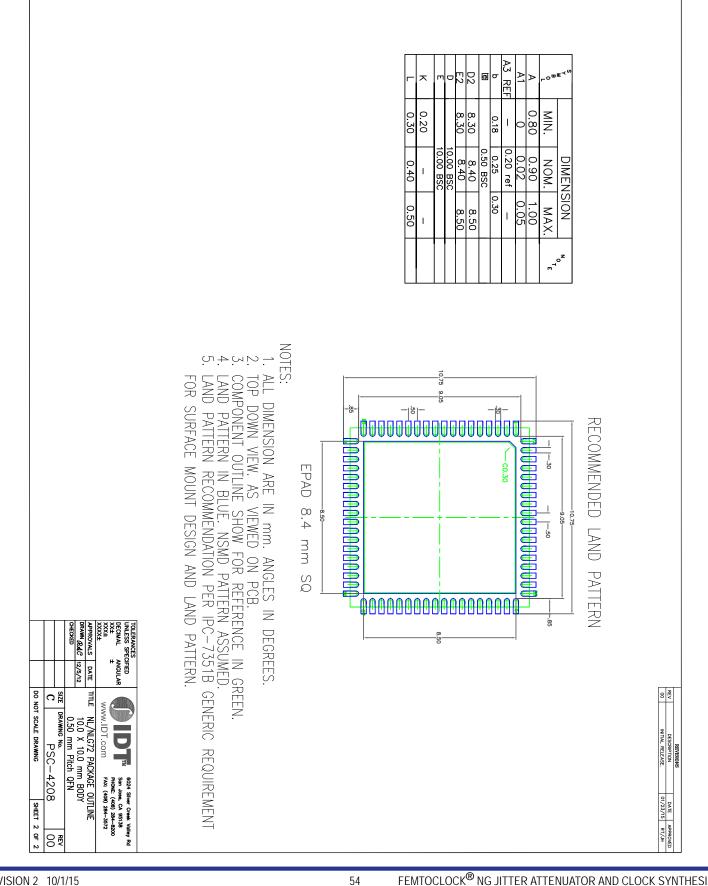
### **Transistor Count**

The transistor count for 8V19N407 is: 46,972

# 72 VFQFN Package Information







# **Ordering Information**

## Table 8. Ordering Information with MISO Output in High Impedance

| Part/Order Number | Marking             | VCO<br>Frequency | Package                  | Shipping<br>Packaging | Temperature   |
|-------------------|---------------------|------------------|--------------------------|-----------------------|---------------|
| 8V19N407Z-19NLGI  | IDT8V19N407Z-19NLGI | 1900 - 2000MHz   | 72 Lead VFQFN, Lead-Free | Tray                  | -40°C to 85°C |
| 8V19N407Z-19NLGI8 | IDT8V19N407Z-19NLGI | 1900 - 2000/0112 | 72 Lead VFQFN, Lead-Free | Tape & Reel           | -40°C to 85°C |
| 8V19N407Z-24NLGI  | IDT8V19N407Z-24NLGI | 2400 - 2500MHz   | 72 Lead VFQFN, Lead-Free | Tray                  | -40°C to 85°C |
| 8V19N407Z-24NLGI8 | IDT8V19N407Z-24NLGI | 2400 - 2300MHZ   | 72 Lead VFQFN, Lead-Free | Tape & Reel           | -40°C to 85°C |

# **Revision History Sheet**

| Rev | Table    | Page | Description of Change   | Date    |
|-----|----------|------|---|---------|
| 2   | Table 6A | 31   | AC Characteristics Table - typographical spec errors for VO <sub>(pp)</sub> :<br>LVPECL Output Voltage Swing<br>(400mV Amplitude Setting) minimum and maximum specs;<br>LVPECL Differential Output Voltage Swing<br>(400mV Amplitude Setting) minimum, typical and maximum specs<br>(1000mV Amplitude Setting) typical spec | 10/1/15 |



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